

Test Report Number: TRB41001, Rev. A
Report Type: Full Compliance Immunity
Reference Standard: Hart InterCivic EMI/EMC Test Plan
Date of Report: 25 November 2014
Product Name: Verity Scan
Model Number: 2005350 (Scan), 2005357 (Ballot Box)
Serial Number: S1400005009
Manufacturer: Hart InterCivic
Representative: Darrick Forester (SLI Global)
Approved By: *Vincent W. Gant*

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1.0 TEST SUMMARY

1.1 Product Description

The unit under test (UUT) was the Verity Scan. This product consisted of two components and the model numbers of these components are as follows: 2005350 (Scan), 2005357 (Ballot Box). The serial number of the scan unit was S1400005009. It is manufactured by Hart InterCivic located in Austin, Texas. This product is a ballot scanner designed for use in commercial and business environments.. The product was continually exercised during testing, as documented in the “configuration” field of the test data sheet.

Additional product information may be found in Appendix H of this report.

1.2 Immunity Test Standards Used

This product was tested in accordance with the Hart InterCivic EMI/EMC Test Plan. This document referenced the immunity test levels defined by the Voting System Guidelines, and the basic test methods outlined in Table 1-1. A copy of this document may be found in Appendix H of this report.

Table 1-1

Specification	Test Method	Performance Criteria
Electrostatic Discharge	IEC 61000-4-2, Ed. 2.0 (2008-12)	(B) Self-Recovering
Radiated RF Immunity	IEC 61000-4-3, Ed. 3.0 (2006-02) + A1 (2007-11) + A2 (2010-03)	(A) No Degradation
Electrical Fast Transient/Burst	IEC 61000-4-4, Ed. 2.0 (2004-07)	(B) Self-Recovering
Surge Immunity	IEC 61000-4-5, Ed. 2.0 (2005-11)	(B) Self-Recovering
Conducted RF Immunity	IEC 61000-4-6, Ed. 3.0 (2008-10)	(A) No Degradation
Power Frequency H-field Immunity	IEC 61000-4-8, Ed. 2.0 (2009-09)	(A) No Degradation
Voltage Dips, Interrupts	IEC 61000-4-11, Ed. 2.0 (2004-03)	(B) Self-Recovering (C) User-intervention Allowed

1.3 Test Results

The UUT **complied** with all the immunity requirements defined by the Hart InterCivic EMI/EMC Test Plan. Test results are summarized in Table 1-2.

Table 1-2

Specification	Test Method	Test Conditions	Compliance
Electrostatic Discharge	IEC 61000-4-2	± 8 kV Contact / HCP, VCP / ± 15 kV Air	Compliant
Radiated RF Immunity	IEC 61000-4-3	80 - 1000 MHz, 10 V/m, 80% 1 kHz AM	Compliant
EFT/Burst	IEC 61000-4-4	± 1.0 kV I/O, ± 2.0 kV AC mains	Compliant
Surge Immunity	IEC 61000-4-5	AC Mains: 1.2/50 us @ ± 2 kV common mode, ± 1 kV differential mode	Compliant
Conducted RF Immunity	IEC 61000-4-6	150 kHz to 80 MHz, 10 Vrms, 80% 1 kHz AM, AC input and I/O	Compliant
Power Frequency H-field Immunity	IEC 61000-4-8	30 A/m, 50/60 Hz, 3 axes	Compliant
Voltage Dips and Interrupts	IEC 61000-4-11	>95% reduction for 0.5 cycles, 30% reduction for 25 cycles, >95% reduction for 250 cycles Nominal increase of 7.5%; nominal decrease of 12.5% 15% line variations	Compliant

1.4 Modifications Required for Compliance

The modifications outlined in Table 1-3 were required for compliance with the electrostatic discharge test. Further documentation regarding these changes may be found in the EMI Test Log in Appendix I of this report.

Table 1-3

Test	Description of Modification
Electrostatic Discharge	<p>Client swapped power bricks with same model # AHM85PS24, SN: K12460009</p> <p>Wrap 3-sides of power brick with lexan label – material is correct, color of label is being worked on</p> <p>Install new back plate with clear lexan label</p> <p>Tied the Thermal Printer's frame ground to the chassis ground on the baseboard. This is a rework on the baseboard in the Verity Scan system</p> <p>This new configuration encapsulates the LED and protects the LED from ESD discharges. Hart using the same red/green bi-color LED we used on the old LED cable.</p> <ul style="list-style-type: none"> • Lens installs into bezel • SPC-060's installed onto back-side of lens • LED plugs into CNX-D Socket • CNX-D plugs onto the back of the Lens

2.0 SCOPE

2.1 Purpose

This report documents the test efforts performed on the Verity Scan to verify compliance to the 2010 version of the Hart InterCivic EMI/EMC Test Plan. This was a formal acceptance test and was conducted on selected days over the period from 6 through 24 October 2014.

2.2 Test Plan

Testing was performed in accordance with the Hart InterCivic EMI/EMC Test Plan. This document defines the critical operational parameters for testing, as well as providing general product information. This is contained in Appendix H of this report.

2.3 Test Parameters

For RF immunity testing, the UUT was placed in a completely anechoic lined chamber (CALC). Support equipment was placed outside the CALC and I/O to the UUT was connected through a penetration panel.

Critical parameters of this product, which were monitored during testing, were defined by the client in their EMI/EMC Test Plan, contained in Appendix H of this report.

2.4 Definition of Performance Criterion for the UUT

The performance criteria for this product are defined in the Hart InterCivic EMI/EMC Test Plan, contained in Appendix H of this report.

3.0 TEST ENVIRONMENT

3.1 Immunity Test Site

The immunity testing was performed at EMCI's test facility in Longmont, Colorado. The radiated field immunity testing was performed in a ferrite lined, shielded enclosure. The enclosure is 10' high x 12' wide x 20' long in size and meets the field uniformity requirements of IEC 61000-4-3. The size of the chamber allows 2-meter separation between the antenna and the UUT.

All other immunity testing was performed on a ground plane measuring approximately 3.0 meters by 4.5 meters (13.5 m^2) and made of 0.125" thick aluminum. The ground plane extended beyond the UUT by 0.5 meters on all sides, was bonded to the facility ground and configured in accordance with the applicable standards.

3.2 Measurement Uncertainty

The measurement uncertainty for EMC Integrity's emissions test facility complies with the requirements defined in CISPR 16. The complete calculations of EMC Integrity's measurement uncertainty is contained in an EMCI memo, which is available upon request. However, a summary of EMCI's measurement uncertainty is given in Table 3-1.

Table 3-1

Test	Measurement Uncertainty	Reference
Electrostatic Discharge	Contact Voltage: 1.9% Risetime: 60 ps Peak Current: 2.8% 30 ns Current: 3.8% 60 ns Current: 9% Indicated Voltage: 1.9%	Accredited Calibration Data Sheet
Radiated RF Immunity	V-pole: 1.2 dB H-pole: 0.7 dB	Worksheets located at H:\EMCI\Administration\Calibration\Measurement Uncertainty
Electrical Fast Transient	Voltage: 0.01 kV Risetime: 0.45 nsec Pulse Width: 1.08 nsec	
Surge Immunity	O.C. Voltage: 0.01 kV Risetime: 0.1 usec Pulse Width: 1.76 usec S. C. Current: 0.91 A Risetime: 0.08 usec Pulse Width: 0.15 usec	
Conducted RF Immunity	0.24 dB	
Power Frequency H-field Immunity	0.87 dB	
Voltage Dips & Interruptions	Voltage: 10.38 Volts Duration: 0.23 msec	

4.0 IEC 61000-4-2, Electrostatic Discharge

4.1 Summary of Test Results

Electrostatic discharge (ESD) testing was performed on the UUT in accordance with the test methods specified by IEC 61000-4-2. Contact discharge was performed at levels of ± 2 kV, ± 4 kV and ± 8 kV at applicable (conductive) test points. Air discharge was performed for non-conductive surfaces of the product at levels of ± 2 kV, ± 4 kV, ± 8 kV and ± 15 kV. Indirect discharge to the horizontal coupling plane (HCP) and the vertical coupling plane (VCP) were also performed to levels of ± 2 kV, ± 4 kV and ± 8 kV.

Note: In the event that no discharge occurs when ESD testing is performed on a product, the data sheet will state “no [contact or air] discharge points found”.

The UUT complied with the requirements of this test.

4.2 Test Setup

The UUT was set up per IEC 61000-4-2 and tested to the levels specified in the Hart InterCivic EMI/EMC Test Plan.

4.3 Special Configurations

N/A

4.4 Performance Criteria

Performance criterion Level B is defined as degradation in performance provided 1) the UUT self-recovers without user-intervention and 2) no data is lost.

4.5 Deviations from Test Procedures

N/a

4.6 Test Data

See APPENDIX A for data sheets, discharge points and test setup pictures.

4.7 Temperature and Humidity

Temperature, relative humidity and barometric pressure are located in the header table for the IEC 61000-4-2 test data sheet.

5.0 IEC 61000-4-3, Radiated RF Immunity

5.1 Summary of Test Results

Radiated RF immunity testing was performed on the UUT in accordance with the test methods specified by IEC 61000-4-3. The UUT was placed on a non-conductive table, 80 cm above the ferrite floor of the completely anechoic-lined chamber. The frequency range for this testing was 80 - 1000 MHz. The UUT was placed 2 meters from the radiating antenna; which was 1.5 meters above the floor of the chamber. Testing was performed in both horizontal and vertical antenna polarizations. The frequency was incremented in 1% steps, with a 3 second dwell time for each test frequency. The UUT was rotated on the table so that all four sides were illuminated in the 10 V/m field. The field was amplitude modulated with a 1 kHz sine wave to a depth of 80%. Performance of the unit was monitored remotely with the support PC, located outside the CALC.

The UUT complied with the requirements of this test.

5.2 Test Setup

The UUT was set up per IEC 61000-4-3 and tested to the levels specified in the Hart InterCivic EMI/EMC Test Plan.

5.3 Special Configurations

N/A

5.4 Performance Criteria

Performance criterion Level A is defined as no degradation in performance beyond manufacturer's specified tolerances.

5.5 Deviations from Test Procedures

N/a

5.6 Test Data

See APPENDIX B for data sheets and test setup pictures.

5.7 Temperature and Humidity

Temperature, relative humidity and barometric pressure are located in the header table for the IEC 61000-4-3 test data sheet.

6.0 IEC 61000-4-4, Electrical Fast Transient/Burst

6.1 Summary of Test Results

Electrical fast transient/burst immunity testing was performed on the UUT in accordance with the test methods specified by IEC 61000-4-4. The UUT AC power was tested via direct injection at a level of ± 2 kV. External I/O in excess of 3 meters was tested via capacitive coupling clamp to a level of ± 1.0 kV.

The UUT complied with the requirements of this test.

6.2 Test Setup

The UUT was set up per IEC 61000-4-4 and tested to the levels per the Hart InterCivic EMI/EMC Test Plan.

6.3 Special Configurations

N/A

6.4 Performance Criteria

Performance criterion Level B is defined as degradation in performance provided 1) the UUT self-recovers without user-intervention and 2) no data is lost.

6.5 Deviations from Test Procedures

N/a.

6.6 Test Data

See APPENDIX C for data sheet and test setup pictures.

6.7 Temperature and Humidity

Temperature, relative humidity and barometric pressure are located in the header table for the IEC 61000-4-4 test data sheet.

7.0 IEC 61000-4-5, Surge Immunity

7.1 Summary of Test Results

Surge immunity testing was performed on the UUT in accordance with the test methods specified by IEC 61000-4-5. The UUT AC power was tested via direct injection at levels of ± 0.5 kV and ± 1.0 kV for differential mode and at levels of ± 0.5 kV, ± 1.0 kV and ± 2.0 kV for common mode. Surges were injected at 0 degrees, 90 degrees, 180 degrees and 270 degrees of the input AC waveform at a rate of one pulse per minute. Five pulses were injected for each test configuration.

The UUT complied with the requirements of this test.

7.2 Test Setup

The UUT was set up per IEC 61000-4-5 and tested to the levels specified in the Hart InterCivic EMI/EMC Test Plan.

7.3 Special Configurations

N/A

7.4 Performance Criteria

Performance criterion Level B is defined as degradation in performance provided 1) the UUT self-recovers without user-intervention and 2) no data is lost.

7.5 Deviations from Test Procedures

N/A

7.6 Test Data

See APPENDIX D for data sheets and test setup pictures.

7.7 Temperature and Humidity

Temperature, relative humidity and barometric pressure are located in the header table for the IEC 61000-4-5 test data sheet.

8.0 IEC 61000-4-6, Conducted RF Immunity

8.1 Summary of Test Results

Conducted RF immunity testing was performed on the UUT in accordance with the test methods specified by IEC 61000-4-6. The UUT was subjected to injected RF signals on its input AC power cable. Injection on the AC leads was performed via a coupling/decoupling network (CDN). Injection on the I/O of the product was performed with an EM clamp. The frequency range for this testing was 150 kHz to 80 MHz. The test frequency was stepped in 1% increments with a three second dwell time for each injection frequency. The injection level used for all testing was 10 Vrms with 1 kHz AM to a depth of 80%.

The UUT complied with the requirements of this test.

8.2 Test Setup

The UUT was set up per IEC 61000-4-6 and tested to the levels specified in the Hart InterCivic EMI/EMC Test Plan.

8.3 Special Configurations

N/A

8.4 Performance Criteria

Performance criterion Level A is defined as no degradation in performance beyond manufacturer's specified tolerances.

8.5 Deviations from Test Procedures

N/A

8.6 Test Data

See APPENDIX E for data sheets and test setup pictures.

8.7 Temperature and Humidity

Temperature, relative humidity and barometric pressure are located in the header table for the IEC 61000-4-6 test data sheet.

9.0 IEC 61000-4-8, Power Frequency H-field Immunity

9.1 Summary of Test Results

Power frequency H-field immunity testing was performed on the UUT in accordance with the test methods specified by IEC 61000-4-8. The UUT was exposed to a 30 A/m field at both 50 and 60 Hz. All three axes (x, y, and z) were immersed in the field for a period of 60 seconds for each configuration. A 1.5 meter by 2.0 meter coil was used for this test and the immersion method was used.

The UUT complied with the requirements of this test.

9.2 Test Setup

The UUT was set up per IEC 61000-4-8 and tested to the levels specified in the Hart InterCivic EMI/EMC Test Plan.

9.3 Special Configurations

N/A

9.4 Performance Criteria

Performance criterion Level A is defined as no degradation in performance beyond manufacturer's specified tolerances.

9.5 Deviations from Test Procedures

N/A

9.6 Test Data

See APPENDIX F for data sheets and test setup pictures.

9.7 Temperature and Humidity

Temperature, relative humidity and barometric pressure are located in the header table for the IEC 61000-4-8 test data sheet.

10.0 IEC 61000-4-11, Voltage Dips and Interrupts

10.1 Summary of Test Results

Voltage dip and interrupt testing was performed on the UUT in accordance with IEC 61000-4-11. The UUT was subjected to the following voltage fluctuations on its AC power input:

>95% reduction for 5 seconds	variation
30% reduction for 0.5 seconds	dip
>95% reduction for 0.01 seconds	dip
7.5% increase & 12.5% decrease	
15% surges from nominal line	

The UUT complied with the requirements of this test.

10.2 Test Setup

The UUT was set up per IEC 61000-4-11 and tested to the levels specified in the Hart InterCivic EMI/EMC Test Plan.

10.3 Special Configurations

N/A

10.4 Performance Criteria

The performance criteria for this test are Levels B and C. Level B is defined as allowing degraded performance provided that the UUT self-recovers without user intervention and no data is lost. Level C is defined as allowing user intervention to regain functionality of the product provided that no permanent damage occurs.

10.5 Deviations from Test Procedures

N/A

10.6 Test Data

See APPENDIX G for data sheets and test setup pictures.

10.7 Temperature and Humidity

Temperature, relative humidity and barometric pressure are located in the header table for the IEC 61000-4-11 test data sheet.

APPENDIX A

Electrostatic Discharge Test Data



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014
Temperature:	20.3°C	Humidity:	35%
Input Voltage:	120Vac/60Hz	Pressure:	843 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Dean Wyant		

B41001-4-2.doc

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Test Location	Voltage Level (kV)	Polarity + -	Number of Pulses	Pulses Per Second	Comments	Criteria Met	Pass / Fail
Indirect Discharge Points (Power brick and UUT w/ballot box)							
VCP	2, 4, 8	x x	10	1	Front Side	A	Pass
VCP	2, 4, 8	x x	10	1	Left Side	A	Pass
VCP	2, 4, 8	x x	10	1	Right Side	A	Pass
VCP	2, 4, 8	x x	10	1	Back Side	A	Pass
HCP	2, 4, 8	x x	10	1	Edge of HCP at Front of UUT (Power Brick Only)	A	Pass
Contact Discharge Points - RED Arrows.							
Figure A2	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Figure A3	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Figure A4	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Figure A5	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Figure A6	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Figure A7	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Figure A8	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Figure A9	2, 4, 8	x x	---	---	No contact charges found	A	Pass
Air Discharge Points - BLUE Arrows.							
Figure A2	2, 4, 8, 15	x x	---	---		---	---
Figure A3	2, 4, 8, 15	x x	---	---		---	---
Figure A4	2, 4, 8, 15	x x	10	1		A	Pass
Figure A5	2, 4, 8, 15	x x	---	---		---	---
Figure A6	2, 4, 8, 15	x x	---	---		---	---
Figure A7	2, 4, 8, 15	x x	10	1		A	Pass
Figure A8	2, 4, 8, 15	x x	---	---		---	---
Figure A9	2, 4, 8, 15	x x	10	1		A	Pass



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

B41001-4-2.doc



Figure A1. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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Figure A2. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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Figure A3. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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Figure A4. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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Figure A5. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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Figure A6. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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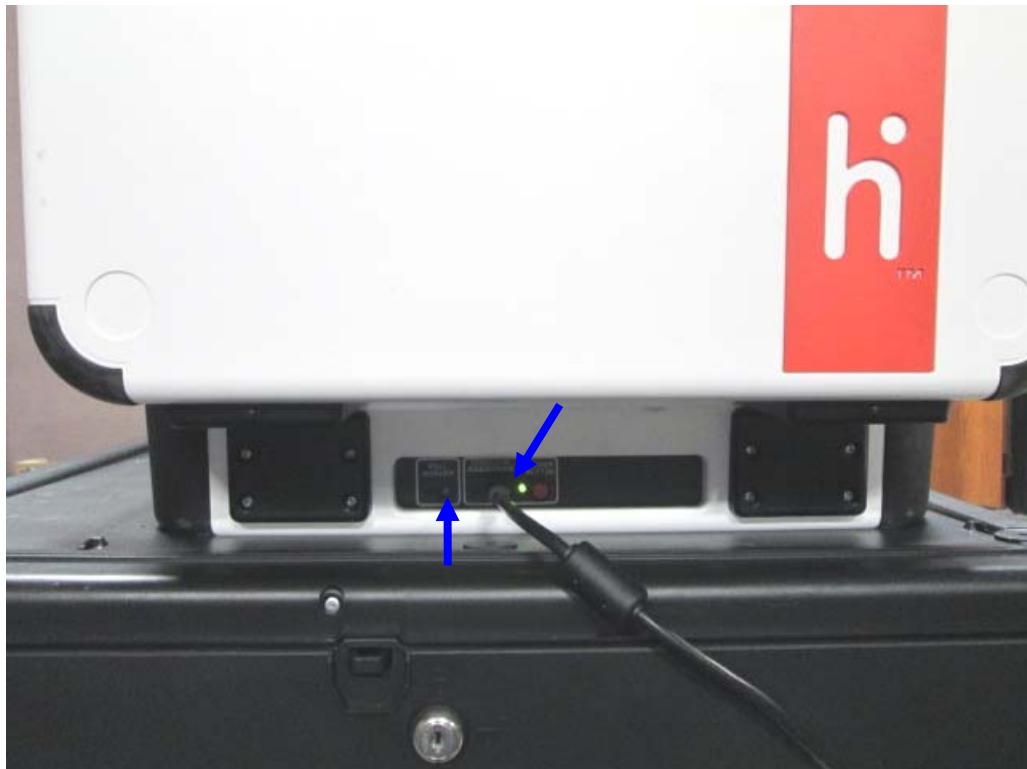


Figure A7. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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Figure A8. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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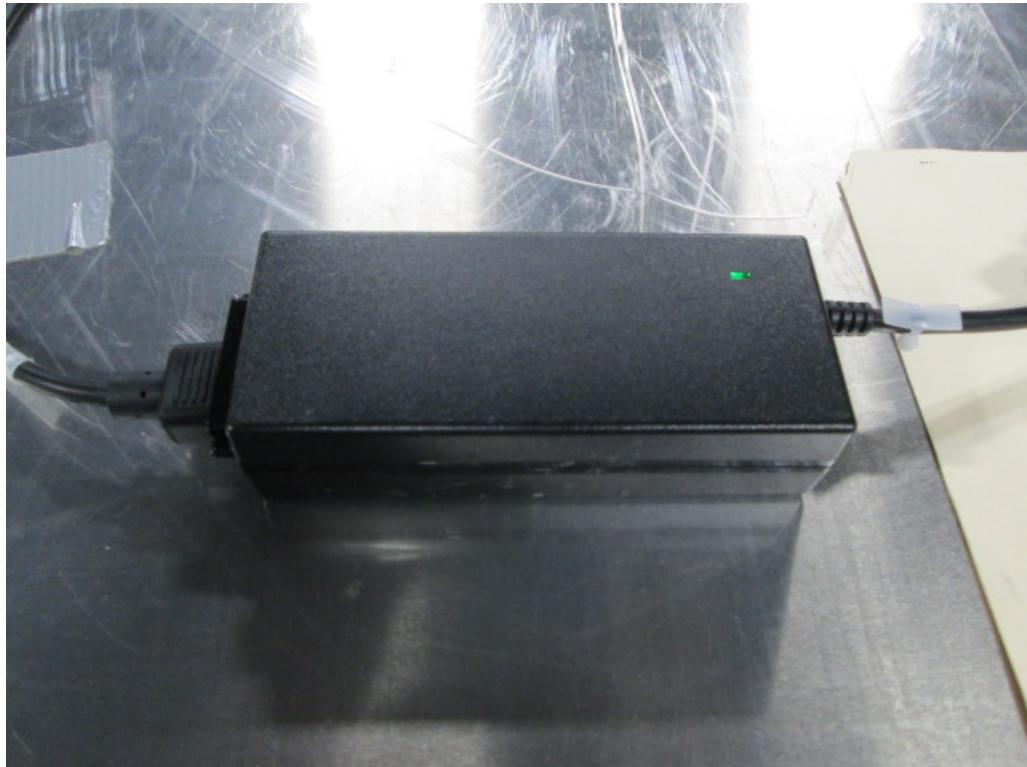


Figure A9. Electrostatic Discharge Test Setup.



Electrostatic Discharge per IEC 61000-4-2

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP1
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-2	Date:	November 4, 2014

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Test Equipment List

ID Number	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
1249	KeyTek	MZ-15/EC	0609258	ESD Gun with TPC-2A SN:0609259	05/19/2014	05/19/2015
1281	EMC Partner	ESD3000	284	ESD Test System	09/24/2014	09/24/2015
1552	EXTECH Instruments	445715		Hygro-Thermometer	09/29/2014	09/29/2015

APPENDIX B

Radiated RF Immunity Test Data



Radiated RF Immunity per IEC 61000-4-3

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	CALC
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-3	Date:	October 6, 2014
Temperature:	20.8°C	Humidity:	36%
Input Voltage:	120Vac/60Hz	Pressure:	839 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Casey Lockhart		

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Frequency (MHz)	Type	Modulation		Form	Step Size (%)	Field (V/m)	Polarity (V or H)	Dwell (sec)	Comments	Criteria Met	Pass / Fail
80 - 1000	AM	80	1kHz	Sine	1		V	3	Front	A	Pass
80 - 1000	AM	80	1kHz	Sine	1		H	3		A	Pass
80 - 1000	AM	80	1kHz	Sine	1		V	3	Right	A	Pass
80 - 1000	AM	80	1kHz	Sine	1		H	3		A	Pass
80 - 1000	AM	80	1kHz	Sine	1		V	3	Back	A	Pass
80 - 1000	AM	80	1kHz	Sine	1		H	3		A	Pass
80 - 1000	AM	80	1kHz	Sine	1		V	3	Left	A	Pass
80 - 1000	AM	80	1kHz	Sine	1		H	3		A	Pass



Radiated RF Immunity per IEC 61000-4-3

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	CALC
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-3	Date:	October 6, 2014

B41001-4-3.doc



Figure B1. Radiated RF Immunity Test Setup – Front Side.



Radiated RF Immunity per IEC 61000-4-3

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	CALC
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-3	Date:	October 6, 2014

B41001-4-3.doc

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Figure B2. Radiated RF Immunity Test Setup – Right Side.



Radiated RF Immunity per IEC 61000-4-3

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	CALC
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-3	Date:	October 6, 2014

B41001-4-3.doc

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Figure B3. Radiated RF Immunity Test Setup – Back Side.



Radiated RF Immunity per IEC 61000-4-3

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	CALC
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-3	Date:	October 6, 2014

B41001-4-3.doc

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Figure B4. Radiated RF Immunity Test Setup – Left Side.



Radiated RF Immunity per IEC 61000-4-3

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	CALC
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-3	Date:	October 6, 2014

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Test Equipment List

ID Number	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
1005	EMCO	3140	1012	Biconilog Antenna	NA	NA
1058	Ray Proof	RF Shield Room	6698	Completely Anechoic Lined Chamber	07/13/2014	07/13/2015
1139	Wiltron	68369B	675016	Synthesized Signal Generator, 10 MHz - 40 GHz	07/30/2014	07/30/2015
1181	EMCI	RFS	NA	Initial Release 02 July 2004	NA	NA
1455	Giga-tronics	GT-8888A	8888A03337	10 MHz to 8 GHz, +20 dBm, 25 Vdc Power Meter	05/13/2014	05/13/2015
1456	Werlatone	C3908-10	98095	1500 Watts, 50 dB Dual Directional Coupler 80 MHz	05/29/2014	05/29/2015
1478	Ophir	5127F	1100	RF Amplifier, 200 Watt, 20 - 1000 MHz	NA	NA
1537	Extech Instruments	445715	Z315813	Hygro-Thermometer	03/21/2014	03/21/2015

APPENDIX C

Electrical Fast Transients/Burst Test Data



Electrical Fast Transient/Burst per IEC 61000-4-4

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-4	Date:	October 6, 2014
Temperature:	22.7°C	Humidity:	35%
Input Voltage:	120Vac/60Hz	Pressure:	839 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Dean Wyant		

B41001-4-4.doc

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Voltage (kV)	Polarity +	Polarity -	Time (sec)	Injection Type	L 1	L 2	L 3	N	P E	Comments	Criteria Met	Pass / Fail
2.0	x		60	CDN	x					AC	2.0	Pass
2.0		x	60	CDN	x						2.0	Pass
2.0	x		60	CDN		x					2.0	Pass
2.0		x	60	CDN		x					2.0	Pass
2.0	x		60	CDN				x			2.0	Pass
2.0		x	60	CDN				x			2.0	Pass
2.0	x		60	CDN	x	x			x		2.0	Pass
2.0		x	60	CDN	x	x			x		2.0	Pass



Electrical Fast Transient/Burst per IEC 61000-4-4

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-4	Date:	October 6, 2014

B41001-4-4.doc



Figure C1. Electrical Fast Transient Test Setup



Electrical Fast Transient/Burst per IEC 61000-4-4

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-4	Date:	October 6, 2014

B41001-4-4.doc

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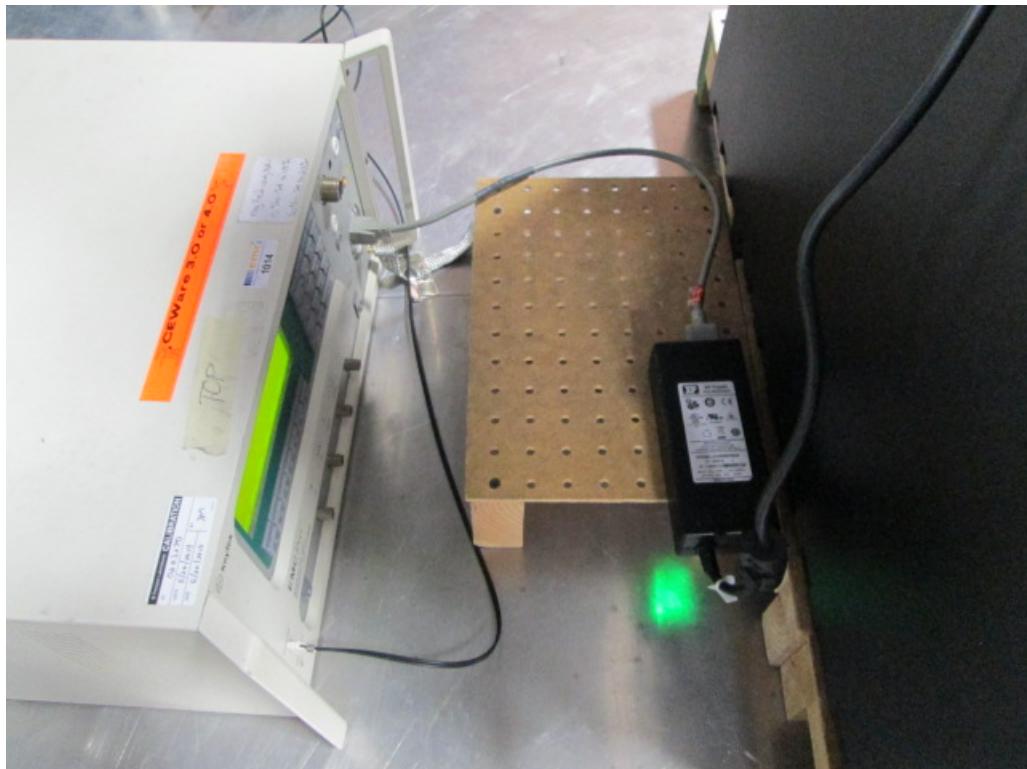


Figure C2. Electrical Fast Transient Test Setup – AC Mains



Electrical Fast Transient/Burst per IEC 61000-4-4

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-4	Date:	October 6, 2014

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Test Equipment List

ID Number	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
1014	KeyTek	EMC Pro	0203270	Advanced EMC Immunity Tester	05/22/2014	05/22/2015
1184	KeyTek	CEWare32	NA	KeyTek EMCPro Control Software for EFT, Surge, H-F	NA	NA
1372	Tektronix	TDS2002B	C103489	Oscilloscope, 60 MHz, 2-channel	01/05/2014	01/05/2015
1548	California Instruments/A metek	1251P	1423A06347	AC Power supply	NA	NA
1553	EXTECH Instruments	445715		Hygro-Thermometer	08/29/2014	08/29/2015

APPENDIX D

Surge Immunity Test Data



Surge Immunity per IEC 61000-4-5

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-5	Date:	October 9, 2014
Temperature:	21.8°C	Humidity:	39%
Input Voltage:	120Vac/60Hz	Pressure:	839 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Mark Novak		

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Voltage (kV)	Polarity + -	L 1	L 2	L 3	N	P E	Phase (deg)	Number of Pulses	Delay (sec)	Comments	Criteria Met	Pass / Fail
0.5	x		x		x		0	5	30	Differential Mode	A	Pass
0.5		x	x		x		0	5	30		A	Pass
0.5	x		x		x		90	5	30		A	Pass
0.5		x	x		x		90	5	30		A	Pass
0.5	x		x		x		180	5	30		A	Pass
0.5		x	x		x		180	5	30		A	Pass
0.5	x		x		x		270	5	30		A	Pass
0.5		x	x		x		270	5	30			
0.5	x		x		x		0	5	30	Common Mode Line	A	Pass
0.5		x	x		x		0	5	30		A	Pass
0.5	x		x		x		90	5	30		A	Pass
0.5		x	x		x		90	5	30		A	Pass
0.5	x		x		x		180	5	30		A	Pass
0.5		x	x		x		180	5	30		A	Pass
0.5	x		x		x		270	5	30		A	Pass
0.5		x	x		x		270	5	30		A	Pass
0.5	x			x	x		0	5	30	Common Mode Neutral	A	Pass
0.5		x		x	x		0	5	30		A	Pass
0.5	x			x	x		90	5	30		A	Pass
0.5		x		x	x		90	5	30		A	Pass
0.5	x			x	x		180	5	30		A	Pass
0.5		x		x	x		180	5	30		A	Pass
0.5	x			x	x		270	5	30		A	Pass
0.5		x		x	x		270	5	30		A	Pass
1.0	x		x		x		0	5	60	Differential Mode	A	Pass
1.0		x	x		x		0	5	60		A	Pass
1.0	x		x		x		90	5	60		A	Pass
1.0		x	x		x		90	5	60		A	Pass
1.0	x		x		x		180	5	60		A	Pass
1.0		x	x		x		180	5	60		A	Pass
1.0	x		x		x		270	5	60		A	Pass
1.0		x	x		x		270	5	60			
1.0	x		x		x		0	5	45	Common Mode Line	A	Pass
1.0		x	x		x		0	5	45		A	Pass



Surge Immunity per IEC 61000-4-5

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-5	Date:	October 9, 2014
Temperature:	21.8°C	Humidity:	39%
Input Voltage:	120Vac/60Hz	Pressure:	839 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Mark Novak		

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Voltage (kV)	Polarity +	-	L 1	L 2	L 3	N	P E	Phase (deg)	Number of Pulses	Delay (sec)	Comments	Criteria Met	Pass / Fail
1.0	x		x				x	90	5	45		A	Pass
1.0		x	x				x	90	5	45		A	Pass
1.0	x		x				x	180	5	45		A	Pass
1.0		x	x				x	180	5	45		A	Pass
1.0	x		x				x	270	5	45		A	Pass
1.0		x	x				x	270	5	45		A	Pass
1.0	x				x	x	0	5	45	Common Mode Neutral		A	Pass
1.0		x			x	x	0	5	45			A	Pass
1.0	x				x	x	90	5	45			A	Pass
1.0		x			x	x	90	5	45			A	Pass
1.0	x				x	x	180	5	45			A	Pass
1.0		x			x	x	180	5	45			A	Pass
1.0	x				x	x	270	5	45			A	Pass
1.0		x			x	x	270	5	45			A	Pass
2.0	x		x				x	0	5	60	Common Mode Line	A	Pass
2.0		x	x				x	0	5	60		A	Pass
2.0	x		x				x	90	5	60		A	Pass
2.0		x	x				x	90	5	60		A	Pass
2.0	x		x				x	180	5	60		A	Pass
2.0		x	x				x	180	5	60		A	Pass
2.0	x		x				x	270	5	60		A	Pass
2.0		x	x				x	270	5	60		A	Pass
2.0	x				x	x	0	5	60	Common Mode Neutral		A	Pass
2.0		x			x	x	0	5	60			A	Pass
2.0	x				x	x	90	5	60			A	Pass
2.0		x			x	x	90	5	60			A	Pass
2.0	x				x	x	180	5	60			A	Pass
2.0		x			x	x	180	5	60			A	Pass
2.0	x				x	x	270	5	60			A	Pass
2.0		x			x	x	270	5	60			A	Pass
2.0	x		x				x	0	5	60	Differential Mode	A	Pass
2.0		x	x				x	0	5	60		A	Pass
2.0	x		x				x	90	5	60		A	Pass
2.0		x	x				x	90	5	60		A	Pass
2.0	x		x				x	180	5	60		A	Pass
2.0		x	x				x	180	5	60		A	Pass
2.0	x		x				x	270	5	60		A	Pass
2.0		x	x				x	270	5	60		A	Pass



Surge Immunity per IEC 61000-4-5

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-5	Date:	October 9, 2014
Temperature:	21.8°C	Humidity:	39%
Input Voltage:	120Vac/60Hz	Pressure:	839 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Mark Novak		

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Voltage (kV)	Polarity +	Polarity -	L1	L2	L3	N	P	Phase (deg)	Number of Pulses	Delay (sec)	Comments	Criteria Met	Pass / Fail
2.0	x		x			x		270	5	60		A	Pass
2.0		x	x			x		270	5	60		A	Pass



Surge Immunity per IEC 61000-4-5

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-5	Date:	October 9, 2014

B41001-4-5.doc



Figure D1. Surge Immunity Test Setup



Surge Immunity per IEC 61000-4-5

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-5	Date:	October 9, 2014

B41001-4-5.doc

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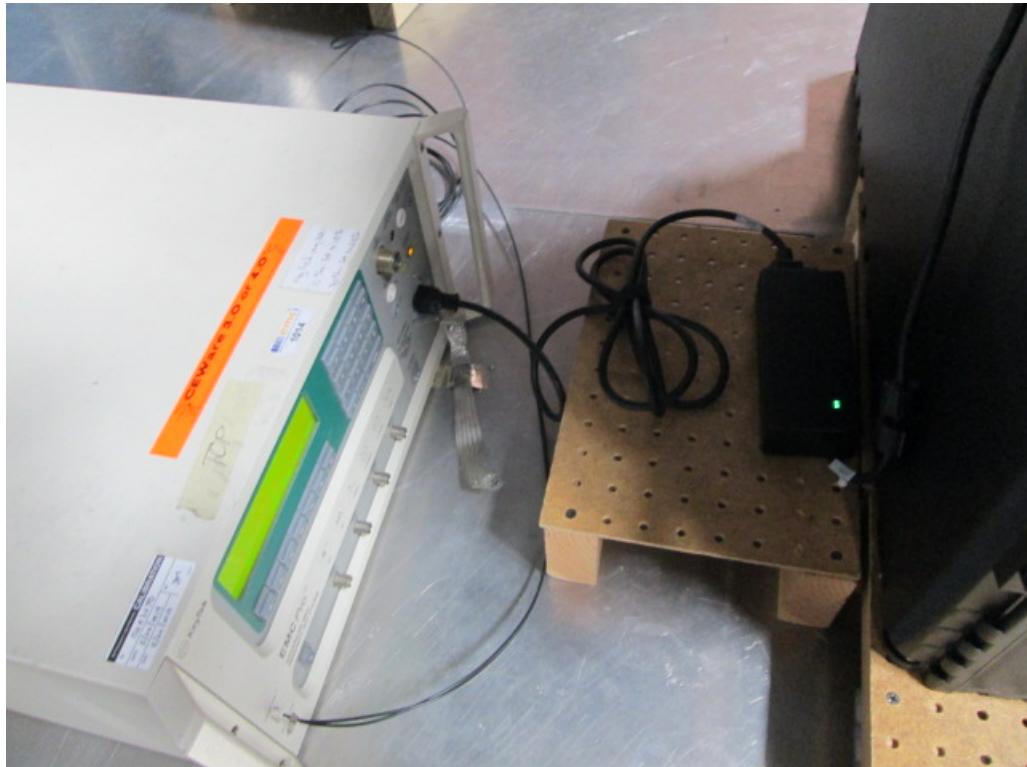


Figure D2. Surge Immunity Test Setup – AC Mains



Surge Immunity per IEC 61000-4-5

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-5	Date:	October 9, 2014

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Test Equipment List

ID Number	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
1014	KeyTek	EMC Pro	0203270	Advanced EMC Immunity Tester	05/22/2014	05/22/2015
1184	KeyTek	CEWare32	NA	KeyTek EMCPro Control Software for EFT, Surge, H-F	NA	NA
1372	Tektronix	TDS2002B	C103489	Oscilloscope, 60 MHz, 2-channel	01/05/2014	01/05/2015
1548	California Instruments/A metek	1251P	1423A06347	AC Power supply	NA	NA
1553	EXTECH Instruments	445715		Hygro-Thermometer	08/29/2014	08/29/2015

APPENDIX E

Conducted RF Immunity Test Data



Conducted RF Immunity per IEC 61000-4-6

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-6	Date:	October 6, 2014
Temperature:	23.3°C	Humidity:	37%
Input Voltage:	120Vac/60Hz	Pressure:	839 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Dean Wyant		

B41001-4-6.doc

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Frequency (MHz)	Type	%	Freq	Level (Vrms)	Dwell (sec)	Comments	Criteria Met	Pass / Fail
0.150 – 80.0	AM	80	1 kHz	10	3	AC using M3 CDN	A	Pass



Conducted RF Immunity per IEC 61000-4-6

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-6	Date:	October 6, 2014

B41001-4-6.doc



Figure E1. Conducted RF Immunity Test Setup



Conducted RF Immunity per IEC 61000-4-6

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-6	Date:	October 6, 2014

B41001-4-6.doc

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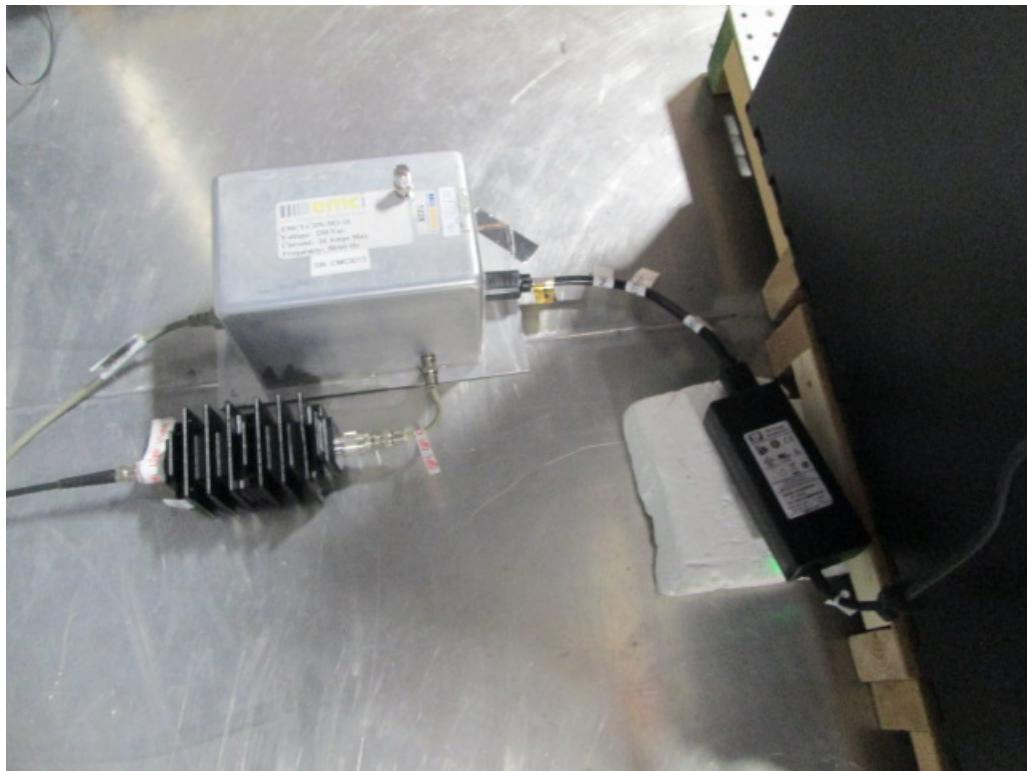


Figure E2. Conducted RF Immunity Test Setup – AC Mains



Conducted RF Immunity per IEC 61000-4-6

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-6	Date:	October 6, 2014

B41001-4-6.doc

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Test Equipment List

ID Number	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
1228	EMCI	EMCI-CDN-M3-16	EMCI013	M3 CDN, 16A, 250 VAC	03/12/2014	03/12/2015
1258	Hewlett Packard	8648C	3537A01572	Signal Generator, 100kHz to 3.2GHz	09/24/2014	09/24/2015
1527	Aeroflex/Wein schel	40-6-34	RX851	Hi pwr Atten 6dB	02/03/2014	02/03/2015
1541	Amplifier Research	75A250A	0445076	75 Watt Amplifier (10kHz - 250MHz)	NA	NA
1548	California Instruments/A metek	1251P	1423A06347	AC Power supply	NA	NA
1553	EXTECH Instruments	445715		Hygro-Thermometer	08/29/2014	08/29/2015

APPENDIX F

Power Frequency H-field Test Data



Power Frequency H-field Immunity per IEC 61000-4-8

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-8	Date:	October 8, 2014
Temperature:	25.5°C	Humidity:	31%
Input Voltage:	120Vac/60Hz	Pressure:	839mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Mark Novak		

B41001-4-8.doc

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Frequency (Hz) 50	Field Strength (A/m)	EUT Axis Location	Dwell Time (sec)	Comments	Criteria Met	Pass / Fail
x		X	60		A	Pass
	x	X	60		A	Pass
x		Y	60		A	Pass
	x	Y	60		A	Pass
x		Z	60		A	Pass
	x	Z	60		A	Pass



Power Frequency H-field Immunity per IEC 61000-4-8

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-8	Date:	October 8, 2014

B41001-4-8.doc



Figure F1. Power Frequency H-field Immunity Test Setup.



Power Frequency H-field Immunity per IEC 61000-4-8

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-8	Date:	October 8, 2014

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Test Equipment List

ID Number	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
1505	EMCI	EMCI-4-8-2m-1.5m	0002	HField Loop, 2m x 1.5m	08/15/2014	08/15/2015
1548	California Instruments/A metek	1251P	1423A06347	AC Power supply	NA	NA
1549	California Instruments/A metek	1251P	1423A05348	AC power supply	NA	NA
1553	EXTECH Instruments	445715		Hygro-Thermometer	08/29/2014	08/29/2015

APPENDIX G

Voltage Dip and Interrupts Test Data



Voltage Dips and Interrupts per IEC 61000-4-11

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-11	Date:	October 6, 2014
Temperature:	23.3°C	Humidity:	37%
Input Voltage:	120Vac/60Hz	Pressure:	839 mb
Configuration of Unit:	Processing Ballots, Playing Audio, Writing to V Drive, Printing to thermal Printer		
Test Engineer:	Dean Wyant		

B41001-4-11.doc

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% Nominal	No. of Cycles	0	90	180	270	Time between dropouts (sec)	Number of tests	Comments	Criteria Met	Pass / Fail
60Hz										
40%	6	x				10	3		A	Pass
40%	6		x			10	3		A	Pass
40%	6			x		10	3		A	Pass
40%	6				x	10	3		A	Pass
70%	0.5	x				10	3		A	Pass
70%	0.5		x			10	3		A	Pass
70%	0.5			x		10	3		A	Pass
70%	0.5				x	10	3		A	Pass
0%	300	x				10	3		A	Pass
0%	300		x			10	3		A	Pass
40%	60	x				10	3		A	Pass
40%	60		x			10	3		A	Pass
40%	60			x		10	3		A	Pass
40%	60				x	10	3		A	Pass
50Hz										
40%	50	x				10	3		A	Pass
40%	50		x			10	3		A	Pass
40%	50			x		10	3		A	Pass
40%	50				x	10	3		A	Pass
70%	50	x				10	3		A	Pass
70%	50		x			10	3		A	Pass
70%	50			x		10	3		A	Pass
70%	50				x	10	3		A	Pass
0%	250	x				10	3		A	Pass
0%	250		x			10	3		A	Pass
Line Voltage Variations										
129Vac Line Voltage Variations (+7.5% of nominal 120V) ran for three hours									A	Pass
105Vac Line Voltage Variations (-12.55% of nominal 120V) ran for three hours									A	Pass
+/-15% voltage variations. 102 VAC to 138VAC for 15 minutes									A	Pass



Voltage Dips and Interrupts per IEC 61000-4-11

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-11	Date:	October 6, 2014

B41001-4-11.doc

FR0100



Figure G1. Voltage Dips and Interruptions Test Setup.



Voltage Dips and Interrupts per IEC 61000-4-11

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-11	Date:	October 6, 2014

B41001-4-11.doc

FR0100

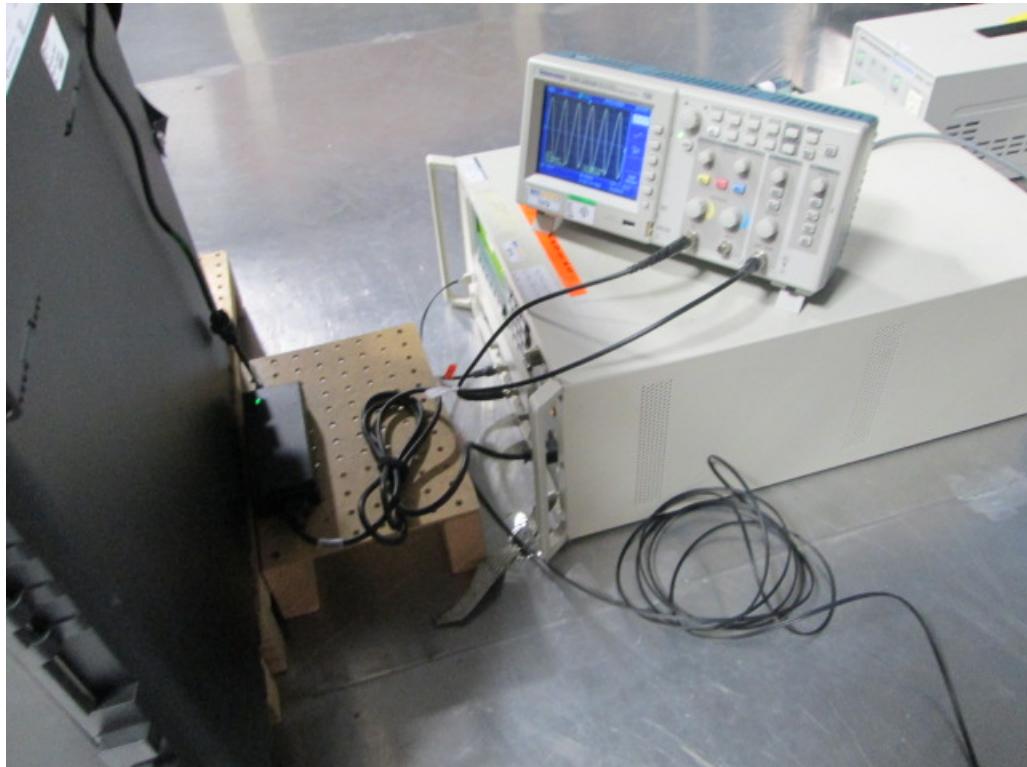


Figure G2. Voltage Dips and Interruptions Test Setup.



Voltage Dips and Interrupts per IEC 61000-4-11

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-11	Date:	October 6, 2014

B41001-4-11.doc

FR0100



Figure G3. Voltage Dips and Interruptions Test Setup. +/-15% voltage variations



Voltage Dips and Interrupts per IEC 61000-4-11

Manufacturer:	SLI Global Solutions	Project Number:	B41001
Customer Representative:	Derrick Forester	Test Area:	GP2
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Standard Referenced:	IEC 61000-4-11	Date:	October 6, 2014

B41001-4-11.doc

FR0100

Test Equipment List

ID Number	Manufacturer	Model #	Serial #	Description	Cal Date	Cal Due
1548	California Instruments/A metek	1251P	1423A06347	AC Power supply	NA	NA
1014	KeyTek	EMC Pro	0203270	Advanced EMC Immunity Tester	05/22/2014	05/22/2015
1184	KeyTek	CEWare32	NA	KeyTek EMCPro Control Software for EFT, Surge, H-F	NA	NA
1553	EXTECH Instruments	445715		Hygro-Thermometer	08/29/2014	08/29/2015
1372	Tektronix	TDS2002B	C103489	Oscilloscope, 60 MHz, 2-channel	01/05/2014	01/05/2015

APPENDIX H

EMI/EMC Test Plan

**Hart InterCivic
Verity Scan, Verity Touch Writer, Ballot Box,
Standard and Accessible Booths
EMC / EMI Test Plan for compliance with the
2005 Voluntary Voting System
Guidelines (VVSG)**

By



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Revision History:

Version	Date	Comments	Contributors
0.9	1/29/14	Initial Release	D. Forester
1.0	3/7/14	Updates based on review	D. Forester
2.0	3/20/14	Update serial numbers and Table 1. Added RFI 2007-05 (COTS)	D. Forester
3.0	4/3/14	Added RFI 2008-10 (EFT)	D. Forester
4.0	10/23/14	Update FCC Class B 10m spec. provide maximum flexibility in testing ,updated exit criteria and added section 4.1	D. Forester
5.0	11/3/14	Add ESD Limit Statement	D. Forester

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Hart InterCivic
Verity EMC / EMI Test Plan

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Hart InterCivic
Verity EMC / EMI Test Plan

1.0 Introduction

1.1 Overview

This test plan covers the EMC (Electromagnetic Compatibility) and EMI (Electromagnetic Interference) test requirements and methods for the Hart InterCivic Verity 1.0 Scan and Touch Writer, Ballot Box, and Standard / Accessible Booths hereafter known as the Unit Under Test (UUT), to the requirements as stated in Election Assistance Commission 2005 Voluntary Voting System Guidelines (VVSG).

1.2 Qualifications

The UUT supplied by Hart InterCivic is representative of product produced in their volume manufacturing process.

1.3 Client

Hart InterCivic
15500 Wells Port Drive
Austin, TX 78728

1.4 Company Restricted Information

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1.5 Reference Documents

- Election Assistance Commission 2005 Voluntary Voting System Guidelines Vol I Version 1.0
- Election Assistance Commission 2005 Voluntary Voting System Guidelines Vol II Version 1.0
- NIST Handbook 150-22, 2008 Edition: National Voluntary Laboratory Accreditation Program – Voting System Testing. May 2008
- EAC Decision on Request for Interpretation 2007-05 (COTS)
- EAC Decision on Request for Interpretation 2008-02 Battery Back Up for Op Scan
- EAC Decision on Request for Interpretation 2008-10 (EFT)
- EAC Decision on Request for Interpretation 2009-03 Battery Back Up for Central Count
- EAC Decision on Request for Interpretation 2010-01 Voltage Levels and ESD Test
- EAC: NOC 07-05: Voting System Test Laboratory (VSTL) responsibilities in the management and oversight of third party testing.
- EAC: NOC 08-001: Validity of Prior Non-Core Hardware Environmental and EMC Testing.
- SLI Standard Lab Procedure SLP-VC-23: Hardware Test Management
- SLI Standard Lab Procedure SLP-VC-24: Subcontractor Laboratory Management
- Hart InterCivic Verity: EMC/EMI, Environmental, Safety Test Plan, Document Number: 4005516, Rev. A.03

2.0 EMC / EMI Test Summary

Table 1: EMC / EMI Test Requirements Summary for Hart InterCivic Verity Scan and Verity Touch Writer

Required	Test	Test Spec.	VVSG Reference	Requirement	Comments
Electromagnetic Emissions Tests					
X	Radiated Electromagnetic Emissions	FCC, Part 15 ANSI C63.4	V1, 4.1.2.9 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	Class B	Internal Battery Not Connected
X	Conducted Electromagnetic Emissions	FCC, Part 15 ANSI C63.4	V1, 4.1.2.9 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	Class B	Internal Battery Not Connected
Electromagnetic Immunity Tests					
X	Electrostatic Disruption	IEC 61000-4-2 (2008) Ed.2.0	V1, 4.1.2.8 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	<p style="margin-left: 20px;">Vote scanning and counting equipment for paper-based systems, and all DRE equipment, shall be able to withstand ± 15 kV air discharge and ± 8 kV contact discharge without damage or loss of data. The equipment may reset or have momentary interruption so long as normal operation is resumed without human intervention or loss of data. Loss of data means votes that have been completed and confirmed to the voter.</p>	<p style="margin-left: 20px;">Voting systems are required to be immune to ESD up to the limits of 8 KV, contact discharge, and 15 KV, air discharge. During exploratory pre-testing investigation of the possibility of windowing effects should be explored. If there are indications that a unit has sensitivity at a lower voltage but not at a higher voltage, test levels shall be added to evaluate the immunity at lower voltage levels. (RFI 2010-01)</p> <p style="margin-left: 20px;">The test levels stated in IEC 61000-4-2, Edition 2.0, contact discharge, are the test method and shall be applied at the specified test level only, 8 kV. Air discharge shall be used where contact discharge cannot be applied and all test levels shall be used (2, 4, 8, 15 kV). (RFI 2010-01)</p>
X	Electromagnetic Susceptibility	IEC 61000-4-3 (1996)	V14.1.2.10 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	<p style="margin-left: 20px;">A field of 10 V/m modulated by a 1 kHz 80% AM modulation over the frequency range of 80 MHz to 1000 MHz</p>	1 GHz
X	Electrical Fast Transient	IEC 61000-4-4 (2004-07) Ed. 2.0	V1, 4.1.2.6 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	<p style="margin-left: 20px;">± 2kV AC & DC external power lines</p> <p style="margin-left: 20px;">± 1kV on Input / Output lines (signal, data, control lines) longer than 3 meters(signal, data, control lines) longer than 3 meters</p> <p style="margin-left: 20px;">Repetition Rate for all transient pulses will be 100 kHz</p>	<p style="margin-left: 20px;">Internal Battery Connected</p> <p style="margin-left: 20px;">The Standard specified in Volume II Section 4.8 is mistakenly cited as IEC 61000-4-4 (1995-01), and should instead properly be cited as IEC 61000-4-4 (2004-07) Ed. 2.0 which supports the 100 kHz repetition rate for all transient pulses specified in Volume I, Section 4.1.2.6(c). (RFI 2008-10)</p>
X	Lightning Surge	IEC 61000-4-5 (1995-02)	V1, 4.1.2.7 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	<p style="margin-left: 20px;">± 2 kV AC line to line; ± 2 kV AC line to earth; ± 0.5 kV DC line to line >10m; ± 0.5 kV DC line to earth >10m; and ± 1 kV I/O sig/control >30m.</p>	Internal Battery Connected
X	Conducted RF Immunity	IEC 61000-4-6 (1996-04)	V1, 4.1.2.11 V1, 4.1.7.1	<p style="margin-left: 20px;">10V rms, 150 KHz to 80 MHz with an 80% AM with a 1 KHz sine wave AC & DC</p>	Internal Battery Connected

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Required	Test	Test Spec.	VVSG Reference	Requirement	Comments
			V1, 2.1.4 (b) V2, 4.8	power 10V rms sig/control >3 m, 150 KHz to 80 MHz with an 80% AM with a 1 KHz sine wave	
X	Magnetic Fields Immunity	IEC 61000-4-8 (1993-06)	V1,4.1.2.12 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	30 A/m at 60 Hz	Internal Battery Connected
X	Electrical Power Disturbance	IEC 61000-4-11 (1994-06)	V1, 4.1.2.5 V1, 4.1.7.1 V1, 2.1.4 (b) V2, 4.8	Voltage dip of 30% of nominal @10 ms; Voltage dip of 60% of nominal @100 ms & 1 sec Voltage dip of >95% interrupt @5 sec Surges of +15% line variations of nominal line voltage Electric power increases of 7.5% and reductions of 12.5% of nominal specified power for a period of up to four hours at each level.	Internal Battery Connected

3.0 Product Description

3.1 Intended Use

For the Verity 1.0 refer to EMC Integrity's detailed Product Data Sheets below starting with section 3.4 Product Information. The Product Data Sheets will be used by EMC Integrity's test technicians during testing and also in writing the test reports.

3.2 Unit Under Test – Verity Scan

Part No.	Serial No.	Description	Qty	Revision No.
2005350	S1400005009 S1400005809 S1400005909	Verity Scan - is Verity's polling place scanning solution for paper ballots. Scan is paired with a purpose-built ballot box to ensure accurate, secure, and private ballot scanning and vote casting for each voter.	3	B
2005357	X14000102	Ballot Box – Used with Verity Scan.	1	A

3.3 Unit Under Test – Verity Touch Writer

Part No.	Serial No.	Description	Qty	Revision No.
2005352	W1400006609 W1400007309 W1400007409 W1400007609	Verity Touch Writer - is a polling place ballot marking device solution for paper ballots. Touch Writer is paired with a commercial off the shelf printer to allow the voter to mark then print their vote selections. Using Touch Writer reviewing and acceptance in conjunction with Verity Scan provides the voter with a reviewable paper ballot that is accurately captured through scanning, for tabulation as a voter's cast vote record (CVR).	4	B
2005358	M14000102	Standard Booth - Used with Touch Writer	1	A
2005359	L14000102	Accessible Booth - Used with Touch Writer	1	A

3.4 Product Information – Verity Scan

Product Information General	
Product Name (as it should appear on test report)	Verity Scan
Model Number (of UUT to be tested)	2005350 (Scan), 2005357 (Ballot Box)
Functional description of product (what is it, what does it do, etc.)	Polling Place Scanning Device – scans paper ballots
List all modes of operation	Ballot Scanner
Can modes be operated simultaneously? If so, explain.	No
What mode(s) will be used for testing?	Ballot Scanning USB Stick Write Test Thermal Printer Test

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Product type (IT, Medical, Scientific, Industrial, etc.)	IT
Is the product an intentional radiator	No
Product Dimensions	Verity Scan Storage/Shipping Carton - 21½"Wx17½"Dx19 ¾"H Device Closed – 18.8"Wx17.39"Dx7.72"H Device Open – 18.8"Wx21.41"Dx20.86"H Ballot Box Collapsed for Storage - 26"Wx5.23"Dx28.25"H Deployed for Use – 26"Wx23.25"Dx28.25"H
Product Weight	Scan - 27lbs Ballot Box - 26.5lbs
Will fork lift be required	No
Applicable Standards, if known	VVSG 2005: FCC Part 15 Class B IEC 61000-4: -2, -3, -4, -5, -6, -8, -11
Describe all environment(s) where product will be used (residential, commercial, industrial, etc.)	Business Recommended Operating Environment Temperature: +50F to +95F Humidity: 10% to 90% Recommended Storage Environment Temperature: -4F to +140F Relative Humidity: <90%
Does product consist of multiple components? (If yes, please describe each system component)	Yes, scanner attaches to ballot box in normal use – it is expected to use this configuration for EMC/EMI testing of Verity Scan
Cycle time > 3 seconds? (If yes, how long?)	Yes for shoeshine testing - ~3 second cycle time Yes for normal usage - ~420 second cycle time
Highest internally generated frequency	Tablet CPU – 1.86GHz
Product Set-up Time	<15 minutes
Boot up time in the event of an unintentional power down	Booting into Windows takes ~60 seconds, we will use simulation tools to exercise the system during testing Booting into Verity Application with polls open takes ~300 seconds

Hart InterCivic Verity EMC / EMI Test Plan						
Identify ALL I/O connections on the unit(s) under test, as well as MAXIMUM associated cable lengths below						
Model No.	Description	I/O Type		Length (m)	Patient Connect? (See Note)	QTY
		UUT- UUT	UUT - SE			
Verity Scan	Polling place scanning device					1
Ballot Box	Ballot Box used with Verity Scan					1
<i>Note: "Patient Connect" column applies only to medical devices.</i>						
3.4.1 Power						
Power Requirements – Verity Scan						
Does/can product connect to AC mains? (If so, can the UUT function when connected to AC?)	Device is DC powered, there is a 85W AC/DC power supply (Yes)					
Input Voltage Rating as it appears on unit, power supply, or power brick	24VDC, 2.4A					
Input Current (specify @ 115 VAC/60 Hz)	XP Power AHM85PS24 - 85W, ~1.0A @ 100V – 0.4A @ 240V Power Brick Input ~1.0A					
Single or Multi-Phase (If multi-phase, specify delta or wye)	Single					
Is input power connector two-prong (Hot & Neutral) or 3-prong (H, N, Ground)	3-prong					
Does UUT have more than 1 power cord? (If yes, explain.)	No					
3.4.2 Services						
Services Requested – Verity Scan						
Testing Required (Formal or Engineering)	Formal					
Special/specific test considerations (i.e. Engineering testing requested, extended range testing, etc.)						
Check all countries/economic areas in which product will be sold.	United States (FCC – emissions only)	<input checked="" type="checkbox"/> X				

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	Canada (CSA – emissions only)
	European Union (CE Mark)
	Australia/New Zealand (C-tick)
	Taiwan (BSMI)
	Korea (KCC)
	Japan (50 Hz)
	Japan (60 Hz)
	China (CCC)
	Others (please specify)
If this is for engineering, will a test report be required?	Yes
Will you require a recommendation for product safety?	TBD

3.5 Product Information - Verity Touch Writer

Product Information General	
Product Name (as it should appear on test report)	Verity Touch Writer
Model Number (of UUT to be tested)	2005352 (Touch Writer) 2005358 (Standard Booth) 2005359 (Accessible Booth)
Functional description of product (what is it, what does it do, etc.)	Polling Place Ballot Marking Device
List all modes of operation	Ballot Marking,
Can modes be operated simultaneously? If so, explain.	No
What mode(s) will be used for testing?	USB Stick Write Test Audio Playing Test USB Printer Test Thermal Printer Test Ballot Marking (Post-test)
Product type (IT, Medical, Scientific, Industrial, etc.)	IT
Is the product an intentional radiator	No
Product Dimensions	Touch Writer Storage/Shipping Carton - 21½"Wx17½"Dx19¾"H

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	Device Closed – 18.8"Wx17.39"Dx7.72"H Device Open – 18.8"Wx21.41"Dx20.86"H Standard Booth Collapsed for Storage – 28.72"Wx5.57"Dx39.69"H Deployed for Use – 28.54"Wx23.17"Dx33.56"H Privacy Screen – adds 23.31" to Height Accessible Booth Collapsed for Storage 38.8"Wx5.83"Dx33"H Deployed for Use – 38.8"Wx25.45"Dx30.19"H Privacy Screen – adds 23.31" to Height
Product Weight	Touch Writer - 27lbs Standard Booth w/ storage bag - 13lbs Accessible Booth w/ storage bag - 14lbs
Will fork lift be required	No
Applicable Standards, if known	VVSG 2005: FCC Part 15 Class B IEC 61000-4: -2, -3, -4, -5, -6, -8, -11
Describe all environment(s) where product will be used (residential, commercial, industrial, etc.)	Business Recommended Operating Environment Temperature: +50F to +95F Humidity: 10% to 90% Recommended Storage Environment Temperature: -4F to +140F Relative Humidity: <90%
Does product consist of multiple components? (If yes, please describe each system component)	Yes – Touch Writer attaches to ballot booth in normal use – it is expected to use this configuration only for EMC/EMI testing of Verity Touch Writer OKI Data Printer – B431d
Cycle time > 3 seconds? (If yes, how long?)	Yes for normal usage - ~420 second cycle time
Highest internally generated frequency	Tablet CPU – 1.86GHz
Product Set-up Time	<15 minutes
Boot up time in the event of an unintentional power down	Booting into Windows takes ~60 seconds, testing with simulation applications takes ~60 seconds. Booting into Verity Application with polls open takes ~600 seconds

Hart InterCivic Verity EMC / EMI Test Plan						
Identify ALL I/O connections on the unit(s) under test, as well as MAXIMUM associated cable lengths below						
Model No.	Description	I/O Type		Length h (m)	Patient Connect? (See Note)	QTY
		UUT- UUT	UUT - SE			
Verity Touch Writer	Polling place scanning device	USB	USB		n/a	1
Verity Access	Audio-Tactile Interface (ATI) module	USB		2m	n/a	1
OKI B431d	Printer		USB	2m	n/a	1
Standard Booth	Standard Booth used with Verity Touch Writer				n/a	1
Accessible Booth	Accessible Booth used with Verity Touch Writer				n/a	1
<i>Note: "Patient Connect" column applies only to medical devices.</i>						
3.5.1 Power						
Power Requirements Verity Touch Writer						
Does/can product connect to AC mains? (If so, can the UUT function when connected to AC?)		Yes (Yes)				
Input Voltage Rating as it appears on unit, power supply, or power brick		24VDC, 2.4A				
Input Current (specify @ 120 Vac/60 Hz)		XP Power AHM85PS24 - 85W, ~1.0A @ 100V – 0.4A @ 240V Power Brick Input ~1.0A				
Single or Multi-Phase (If multi-phase, specify delta or wye)		Single				
Is input power connector two-prong (Hot & Neutral) or 3-prong (H, N, Ground)		3-prong				
Does UUT have more than 1 power cord? (If yes, explain.)		No				
3.5.2 Services						
Services Requested Verity Touch Writer						
Testing Required (Formal or Engineering)		Formal				
Special/specific test considerations (i.e. Engineering testing requested, extended range testing, etc.)						
Check all countries/economic areas in which		United States (FCC – emissions)			<input checked="" type="checkbox"/> X	

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product will be sold.	only)				
	Canada (CSA – emissions only)				
	European Union (CE Mark)				
	Australia/New Zealand (C-tick)				
	Taiwan (BSMI)				
	Korea (KCC)				
	Japan (50 Hz)				
	Japan (60 Hz)				
	China (CCC)				
	Others (please specify)				
If this is for engineering, will a test report be required?					
Will you require a recommendation for product safety?					
3.5.3 Support Equipment (SE) – Detailed Information					
Support Equipment (SE)					
Name	Model No.	Serial No.	Description		
OKIDATA	B431d	AK43004558A0	Ballot Printer		
		AK46022060A0			
		AK46022066A0			
		AK47007784A0			
		AK47007789A0			
SE I/O Cabling					
Model No.	Description		Shielded?	Length	Quantity
N/A					
SE Software/Firmware					
Name	Version/Revision	Functionality			
3.6 Engineering Changes					
Engineering Change (EC) #		Description			
N/A					

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3.7 Power Supplies

Manufacturer	Model	Serial No.	Input	Output and Type
XP Power	AHM85PS24 – 85W	K12460073 / 2005415	~1.0A	@ 100V – 0.4A @ 240V

3.8 Accessories

Type	Model	Function
Verity Test Ballots		
Verity Keys		Load Election
Verity vDrives (Apacer / AMP)		Write Data to vDrive
USB Drives (2 per device)		
Thermal paper (1 extra per device)		
Scanner cleaning kit		

3.9 Oscillator Frequencies

Frequency	Description of Use
0.307Mhz	
12Mhz	
240Mhz	
12Mhz	ATI, Base Board
24Mhz	ATI, PDI Scanner
1.86GHz	CPU

3.10 Interconnecting Cables

Type	Description	Shielded?	Length	Quantity

3.11 Software

Type	Version	Description
Verity Scan	0.17.11.16874	For Verity Scan
Verity Touch Writer	0.17.11.16874	For Verity Touch Writer

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4.0 Test Plan

4.1 Units Under Test

Multiple Units Under Test of the same model with unique serial numbers may be used throughout EMC/EMI testing meeting the following criteria:

- To maximum scheduling flexibility
- UUT are identical models
- All hardware components are listed in Vendor's bill of materials

List of Units Under Test can be found in section 3.2 and 3.3 of this document.

4.2 Operating Modes and Configurations for EMC Testing

4.2.1 Operating Mode

Prior to and during testing, proper operation of the UUT shall be confirmed using Hart InterCivic software. An operational status check shall be performed prior to fully exercise the UUT and ensure that no damage has occurred as a result of the test.

Verity Scan and Very Touch Writer will be in a test election mode and the following Verity applications will be executed:

- Shoe Shine test application – provides a method of exercising the integrated scanner in Verity Scan. When application runs a sheet of paper is inserted into the scanner and the scanner will continuously scan the inserted paper through its paper feeder, the scanned images are not saved. To stop the scanning process the paper must be grabbed and pulled out of the scanner. The scan rate is approximately once every 15 seconds
- Audio Test application – is used to test the Audio playback in Verity Touch Writer. This requires the Verity Access audio-tactile interface device be plugged into the Access port on the Verity Touch Writer and headsets or speakers be plugged in to the audio out port on the Access device. The audio played is a file that is specified in the applications folder. The audio track should be short, less than 5 seconds long; the audio application will play the MP4 audio file every 23 seconds with 17 second delay until the application is closed.
- USB Stick Test – is an application to write data to either of the USB ports that are inside Verity Scan and Touch Writers secure device compartment. This application uses a command line to specified location of the file to write and how often to write, the data written is Date-Time; by default the Date-Time is written at an approximate once a minute rate.
- Printer Test - is an application to print to the thermal printer integrated into Verity Scan and Touch Writers, in addition it can be configured, thru a configuration file, to print data to a USB printer connected to the Touch Writers printer port. The data printed is Date-Time; by default the Date-Time is printed at an approximate once a minute rate and once a five minute rate.

4.2.2 Device Setup

- Touch Writer will include OKI B431d COTS printer
- Prior to each test Scan will have scanner cleaned prior to running Verity Scan application
- Run Verity Scan application:

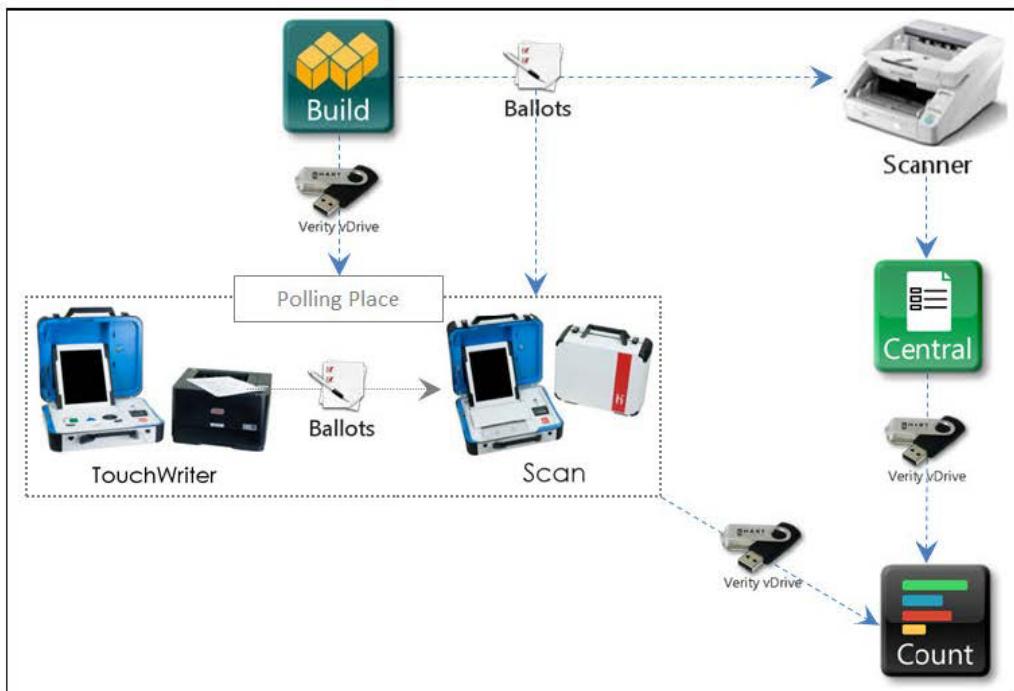
Hart InterCivic
Verity EMC / EMI Test Plan

- Configure C:\Verity directory with proper database
- Load election
- Scan ballots (5 each)
- Suspend or Close election
- Run Verity Touch Writer application:
 - Load election
 - Print 1 ballot
- Run test applications:
 - Verity Scan:
 - Shoeshine (configure C:\Verity directory with proper database), USB Stick Test, Printer Test
 - Verity Touch Writer:
 - USB Stick Test, Audio Test, Printer Test, Mark / Print Ballot

4.2.3 Configurations

The following image is a general workflow of all Verity Voting system components working together.

Figure 1: Verity Voting Configuration



4.3 Treatment of Test Failures

Hart InterCivic
Verity EMC / EMI Test Plan

Failures of EMC tests or failures of the exercising software to perform shall be documented in the EMC test report.

4.4 Test Documentation

A test report shall be attained from the test lab that meets the pertinent requirements of EN45001, and ISO/IEC17025, "General Requirements of Testing and Calibration Laboratories".

4.5 Test Facility Location

EMC Integrity, 1736 Vista View Drive, Longmont CO 80504

Hart InterCivic
Verity EMC / EMI Test Plan

5.0 EMC / EMI Tests

5.1 Electromagnetic Emissions

Objective: To verify that the electromagnetic emissions generated by the product under normal use and in the product's intended environment are below a level as specified by the VVSG.

5.1.1 Radiated Electromagnetic Emissions

Test Method: FCC Part 15, Radio Frequency Devices

Deviations from Test Method: None

Exit Criteria: The UUT shall meet the following emissions limits:

Frequency Band (MHz)	Class B Equipment 10m Measurement Distance (dBuV/m)
30 – 88	29.5
88-216	33.1
216 – 960	36.6
960-1000	43.5
(GHz) 1000-5000	43.5

5.1.2 Conducted Electromagnetic Emissions

Test Method: FCC Part 15, Radio Frequency Devices

Deviations from Test Method: None

Exit Criteria: The UUT shall meet the following emissions limits:

Frequency Band (MHz)	Class B Equipment Quasi-Peak Measurement (dBuV)	Average Measurement (dBuV)
0.15 – 0.5	66 decreasing with the log of the frequency to 56	56 decreasing with the log of the frequency to 46
0.5 – 5.0	56	46
5.0 – 30	60	50

5.2 Electromagnetic Immunity

Objective: To verify that the product performs as intended when exposed to different types of electromagnetic energies that may be encountered under normal use in the product's intended environment.

5.2.1 Immunity Compliance Criteria

Criteria A: The UUT shall be able to withstand the test without disruption of normal operation or loss of data.

Criteria B: The UUT shall be able to withstand the test without damage or loss of data. The equipment may reset or have momentary interruption so long as normal operation is resumed without human intervention or loss of data. Loss of data means votes that have been completed and confirmed to the voter.

Hart InterCivic
Verity EMC / EMI Test Plan

Criteria C: The COTS and support equipment may have temporary loss of function or degradation of performance, the correction of which requires operator intervention or system reset.

Electrostatic Disruption

Test Method: IEC61000-4-2, Ed. 2, Electrostatic Disruption Test, (2008)

Test Levels: Will not exceed the required ESD limits for all ESD test levels.

Test Location	Discharge Voltage +/- (kV)
Indirect Contact: HCP	2.00, 4.00, 8.00
Indirect Contact: VCP	2.00, 4.00, 8.00
Direct Contact to Metallic Surfaces	2.00, 4.00, 8.00
Air Discharges to Insulated Surfaces	2.00, 4.00, 8.00, 15.00

Deviations from Test Method: None

Exit Criteria: B

5.2.2 *Electromagnetic Susceptibility*

Test Method: IEC61000-4-3, Radiated, Radio-Frequency, Electromagnetic Field Immunity Test, (1996)

Test Levels:

Frequency Range (MHz)	Test Level (V/m)	Modulation / Sweep
80.0 to 1000.0	10	80% AM at 1.0kHz 1% steps with 3s dwell
Clock Frequencies	10	80% AM at 1.0kHz 1% steps with 3s dwell

Deviations from Test Method: None

Exit Criteria: A

5.2.3 *Electrical Fast Transient*

Test Method: IEC61000-4-4, Electrical Fast Transient Test, (1995-01)

Note: Repetition Rate for all transient pulses will be 100 kHz

Test Levels:

Coupling Mode	Test Voltage +/- kV
AC & DC Line Cord	2.0
All external wires >3m no control	1.0

Deviations from Test Method: None

Exit Criteria: B

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Verity EMC / EMI Test Plan

5.2.4 Lightning Surge

Test Method: IEC61000-4-5, Lightning Surge Test, (1995-02)

Test Levels:

Coupling Mode	Test Voltage +/- kV
Differential Mode	2
Common Mode	2
Differential Mode >10m	0.5
Common Mode >10m	0.5
I/O sig/control >30m	1

Deviations from Test Method: None

Exit Criteria: B

5.2.5 Conducted RF Immunity

Test Method: IEC61000-4-6, Immunity to Conducted Disturbances, Induced by Radio-Frequency Fields, (1996-04)

Test Levels:

Test Point	Frequency Range (MHz)	Test Level (Vrms)	Modulation / Sweep
AC & DC Power >3m in length	0.150Khz to 80Mhz	10	80% AM at 1.0Khz 1% steps with 3s dwell
I/O cables >3M in length	Clock Frequencies	10	80% AM at 1.0Khz 1% steps with 3s dwell

Deviations from Test Method: None

Exit Criteria: A

5.2.6 Magnetic Fields Immunity

Test Method: IEC61000-4-8, Power Frequency Magnetic Field Immunity Test, (1993-06)

Test Levels: 30 A/m at 60 Hz

Deviations from Test Method: None

Exit Criteria: A

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5.2.7 ***Electrical Power Disturbance***

Test Method: IEC61000-4-11, Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests, (1994-06)

Test Levels:

Electrical Power Disturbance
30% dip @ 10ms
60% dip @ 100 ms and 1 sec
> 95% interrupt @ 5 sec
Surges of $\pm 15\%$ line variations of nominal line voltage
Electric power increases of 7.5% and reductions of 12.5% of nominal specified power supply for a period of up to four hours at each power level

Deviations from Test Method: None

Exit Criteria: A

Hart InterCivic
Verity EMC / EMI Test Plan

6.0 Handling Hardware Anomalies and Incidents

6.1 Hardware Test Anomalies

An anomaly with the subcontractor's test equipment or a procedural misstep can cause a test to fail. For any suspected test equipment issue or procedural error, analysis will be performed and the decision whether to continue testing based on the severity of the anomaly will be appropriately tracked. The subcontractor test lab will issue a corrective action to address any test equipment and/or procedure errors. This is part of the hardware test subcontractor's quality system process that allows the hardware test lab to train all personnel, repair/calibrate equipment, and prevent any recurrence.

6.2 Hardware Incident Process

For every test failure of any voting system component at the hardware test lab, the lab completes a data sheet (per their laboratory procedures and templates) and immediately informs the SLI Hardware Specialist. This can be communicated in the daily status update, with the data sheet attached.

- **Failure Analysis:** Once a failure has occurred, the SLI Hardware Specialist will be involved with the subcontractor test lab(s) to identify the hardware discrepancy in the device. The results of the analysis will be documented and tracked in the discrepancy reporting tool, and the ECO database under Hardware Incident. The analysis will focus on the failure, what caused the failure, the severity (minor or major), and possible impacts to other testing.
- **Mitigation:** The SLI Hardware Specialist monitors any work done by the manufacturer, with the full understanding of what is occurring and why.
 - The Manufacturer will document what work is done and the SLI Hardware Specialist will sign off on or can stop the work at any time.
 - The Hardware Specialist will determine the number of "minor" fixes the manufacturer can incorporate without a re-start of the test.
 - A **minor** change made by the manufacturer can include grounding the chassis or adding ferrites.
 - Any **major** component replacement is cause for failing a test and requiring a re-start. Example: Bad motherboard. Analysis: What was the cause; did the ESD test cause the motherboard to malfunction? Does this impact other hardware tests? The Manufacturer can only replace like for like components and this process must be monitored by the SLI Hardware Specialist.
 - Any modification to the equipment is followed up with the related manufacturer EC(s). All related ECs must be entered into the hardware test report and the certification test report

When issues are identified during hardware environmental testing, they result in discrepancies. Discrepancies are tracked in the ECO database under the "Hardware Test Incident" category. The incident number will be tracked along with the equipment that is taken out of testing due to the failure.

APPENDIX I

EMI Test Log



EMI Test Log

Manufacturer:	SLI Global Solutions.	Project Number:	B41001
Model:	2005350 (Scan) Rev. B	S/N:	S1400005009
Customer Representative:	Derrick Forester		
Standard Referenced:			FR0105

10m Emissions

Test	Test Code	Date	Event	O T	Time (hrs)	Result	Initials
	6001	October 3, 2014 1100-1130	Initial setup time Radiated Emissions Engineering / Trouble-Shooting		0.5	Complete	MT
RE	1342	1130-1200	Test #1: Radiated Emissions, 30 MHz - 1 GHz, 8 Rads, 4 Heights, 3 sec. dwell, ref. level = 80 dBuV, 10 meter distance 120 VAC / 60 Hz		0.5	---	MT
		1200-1230	Lunch		---	---	MT
		1230-1400	Continue: Test #1: Radiated Emissions, 30 MHz - 1 GHz, 8 Rads, 4 Heights, 3 sec. dwell, ref. level = 80 dBuV, 10 meter distance 120 VAC / 60 Hz		1.5	Pass	MT
RE	1341	1400-1500	Test #2: Radiated Emissions, 1 GHz - 10 GHz, 16 Rads, 2 Heights, 3 sec. dwell, ref. level = 107 dBuV, 3 meter distance 120 VAC / 60 Hz		1.0	Pass	MT
CE	2341	1500-1600	Test #3: Conducted Emissions, 150 kHz - 30 MHz 120 VAC / 60 Hz		1.0	Pass	MT

Regular hours:	4.5
Overtime/Prem hours:	
Total hours:	4.5

Ground Planes / CALC

Test	Test Code	Date	Event	O T	Time (hrs)	Result	Initials
4-3	4354	October 6, 2014 0800 - 1200	Radiated RF Immunity 10 V/m, 80 - 1000 MHz, 1% Step, 80% AM, 1kHz sine, 3s dwell 120 VAC / 60 Hz		4.0	Pass	CL
4-4	4411	October 6, 2014 1230 - 1330	Electrical Fast Transient / Burst Mains: +/- 2kV, I/O: +/- 1kV, rep rate 100 kHz. (AC main & No I/O >3m) 120 VAC / 60 Hz		1.0	Pass	MN

EMC INTEGRITY, INC.
Test Report # TRB41001, Rev. A

Ground Planes / CALC

Test	Test Code	Date	Event	O T	Time (hrs)	Result	Initials
4-6	4622	October 6, 2014 1330 - 1500	Conducted RF Immunity 10Vrms, 0.15 - 80 MHz, 1% Step, 80% AM, 1kHz sine, 3s dwell (AC main & No I/O >3m) 120 VAC / 60 Hz		1.5	Pass	MN
4-11	4191	October 6, 2014 1500 - 1600	Voltage Dips and Interruptions 70% nom, 0.5 cycles / 40% nom, 5 cycles / 0% nom, 250 cycles (See Protocol for Specifics) 120 VAC / 60 Hz		1.0	Pass	MN
4-11	4194	October 8, 2014 0800 - 1200	Voltage Dips and Interruptions Electric power increases of 7.5% and reductions of 12.5% of nominal specified power. (See Protocol) TBD		4.0	---	MN
---	---	1200 - 1230	Lunch		---	---	MN
---	---	1230 - 1500	Continuing Electric power increases of 7.5% and reductions of 12.5%		2.5	Pass	MN
4-8	4831	1500 - 1600	Power Frequency H-Field Immunity 30A/m, 50 / 60 Hz, 3 axes 120 VAC / 60 Hz		1.0	Pass	MN
4-5	4596	October 9, 2014 0800 - 1400	Surge Immunity Mains: +/- 2kV CM, +/- 2kV DM, (0, 90, 180, 270) (See Protocol for Specifics) 120 VAC / 60 Hz		6.0	Pass	TW
4-2	4295	1400-1600	Electrostatic Discharge +/- 2, 4, 8kV Contact, +/- 2, 4, 8, 15kV Air (See Protocol for Specifics) 120 VAC / 60 Hz		---	---	TW
			ESD straps measure to 935 and 953 K Ohms, performed ESD pre-test.		---	---	TW
			At -15kV, air discharges caused the led to go out		---	---	TW
			Modification for compliance: Client swapped power bricks with same model # AHM85PS24, SN: K12460009 Original power brick SN: K1260015 No problems occurred with replacement power brick		---	---	TW
			Completed all VCP and HCP testing and completed all testing on power brick		2.5	---	TW
		October 10, 2014 0800-1000	Air discharge at +8.4 kV to power inlet board connector. Air discharge at +8.4kV and +15kV to printer caused the ballot to stop "shoe shining". The "shoe shine" application is for testing only. With normal user operation the ballot would not be spit back out. This is not considered a failure. Air discharge found at +15kV to LED above printer. Worker poll button on back and touch screen. Air discharge found at -15kV to printer, LCD above printer, touch screen, worker poll button, power button and power inlet cable on back. -15kV air discharge to poll worker LED caused it not to light at the end of the test -15kV air discharge to poll worker LED caused the LED to go out.		2.0	Fail	KJ

EMC INTEGRITY, INC.
Test Report # TRB41001, Rev. A

Ground Planes / CALC

Test	Test Code	Date	Event	O T	Time (hrs)	Result	Initials
	5002	1000-1200	ESD engineering / Trouble-Shooting		2.0	Complete	KJ

Regular hours:	32.0
Overtime/Prem hours:	
Total hours:	32.0

Change Order #: CO2014071803_B							
4-2	4295	October 22, 2014 0800 -1200	The modifications done to the unit for this retest are: A - Wrapped 3 sides of the power brick with Lexan Label\\ B – Installded new backplate with clear Lexan Label over the LEDs		4.0	---	MN
---	---	---	Pretest OK, ground cables 951 and 915 Ohms		---	---	MN
---	---	---	This is a different unit from the last time these models were tested. This is sn: S1400005809. Previous unit was sn: S1400005009 At +15kV on led above printer, stopped the unit, “shoe shine” operation did not continue and unit shutdown. Installed a new test utility and could not repeat the failure. 15kV discharge to “teeth” on printer caused unit to shutdown. Poll worker LED no longer functions.		---	Fail	MN
---	---	1200 - 1230	Lunch		---	---	MN
---	---	1230 - 1330	Did a bit of trouble shooting on the LED above printer and the “teeth” – the unit stopped operating. Had to reboot unit.		1.0	---	MN

Regular hours:	5.0
Overtime/Prem hours:	
Total hours:	5.0

Change Order #: CO2014071803_E							
4-2	4295	October 24, 2014 1230 -1630	The modifications done to the unit for this retest are: A - Wrapped 3 sides of the power brick with Lexan Label\\ B – Installded new backplate with clear Lexan Label over the LEDs Replaced the scanner component Replaced the baseboard Replaced the back panel. All components from the same mdel and bill of materials.		4.0	---	MN
---	---	---	Pretest OK, ground cables 951 and 915 Ohms		---	---	MN

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Test Report # TRB41001, Rev. A

---	---	---	<p>. This is sn: S1400005809</p> <p>At +15kV on led above printer, stopped the unit, "shoe shine" operation did not continue and unit shutdown. Installed a new test utility and could not repeat the failure. 15kV discharge to "teeth" on printer caused unit to shutdown. Poll worker LED no longer functions.</p>	---	Fail	MN
4-2	4295	November 4, 2014 0800-1000	<p>Re-Test</p> <p>Electrostatic Discharge</p> <p>+/- 2, 4, 8kV Contact, +/-2, 4, 8, 15kV Air</p> <p>(See Protocol for Specifics)</p> <p>120 VAC / 60 Hz</p>	2.0	Pass	DW

Regular hours: 4.0

Overtime/Prem hours:

Total hours: 4.0

APPENDIX J

Laboratory Accreditations



Nemko Laboratory Authorization

Authorization: ELA 215

EMC Laboratory: **EMC Integrity, Inc.
1736 Vista View Drive
Longmont, Colorado 80504
USA**

Scope of
Authorization: **All CENELEC standards [ENs] for EMC that are listed on the
accompanying page, and all of the corresponding CISPR,
IEC and ISO EMC standards that are listed on the
accompanying page.**

Nemko has assessed the quality assurance system, the testing facilities, qualifications and testing practices of the relevant parts of the organization. The quality assurance system of the Laboratory has been validated against ISO/IEC 17025 or equivalent. The laboratory also fulfils the conditions described in Nemko Document NLA -10. During the visit by the Nemko representative it was found that the Laboratory is capable of performing tests within the Scope of the Authorisation.

Accordingly, Nemko will normally accept test results from the laboratory on a partial or complete basis for certification of the products.

In order to maintain the Authorisation, the information given in the pertinent NLA-10 must be carefully followed. Nemko is to be promptly notified about any changes in the situation at the Laboratory, which may affect the basis for this Authorisation. The Authorisation may be withdrawn at any time if the conditions are no longer considered to be fulfilled.

The Authorisation is valid through June 30, 2015.

Dallas, Texas, USA.

For and on behalf of Nemko AS:

A handwritten signature in black ink that appears to read "T.B. Ketterling".

T.B. Ketterling,
Nemko ELA Co-ordinator
Region: North America

SCOPE OF AUTHORIZATION

Capability to perform a basic test implies also that any product (family) standard calling up this basic test is also within the scope if mentioned below or not.

<i>Generic & Product –Family Standards</i>		
EN 55011 :1998+A1 :1999 +A2 :2002 EN 55011:2007 +A2:2007 EN 55011:2009 +A1:2010 CISPR 11:1997 (Modified) + A1:1999 + A2:2002 CISPR 11 Ed. 4.1 CISPR 11 Ed 5.1 (2010-7)	EN55014:1997 +A1:2008 EN 55014-1:2006 +A1:2009 EN 55014-1:2000 +A1:2001 + A2:2002 CISPR 14-1:2000 +A1:2001 + A2:2002 CISPR 14-1:2005 +A1:2008 CISPR 14-1 Ed. 5.0	EN 55014-2:1997 + A1:2001 CISPR 14-2:1997 + A1:2001 +A2:2008 CISPR 14-2 Ed. 1.2
EN 55022: 1998+ A1:2000, +A2:2003 CISPR 22: 2003+A1:2004 CISPR 22:2005 (Modified) EN55022:2006 CISPR 22 Ed. 5.2 CISPR 22 Ed. 6.0 (2008-09) EN 55022 +A1: 2007 EN 55022:2010	EN 55024: 1998 +A1:2001, +A2:2003 CISPR 24: 1997 +A1:2001, +A2:2002 CISPR 24 Ed. 1.0 EN 55024:2010	EN 61000-6-1 :2007 IEC 61000-6-1 Ed. 2.0 EN 61000-6-1: 2001
EN 61000-6-2:2005 IEC 61000-6-2 Ed. 2.0	EN 61000-6-3 :2007 IEC 61000-6-3 Ed. 2.0 EN 61000-6-3: 2001 +A1 :2004	IEC 61000-6-2 Ed. 2.0 EN 61000-6-2: 2005 IEC 61000-6-2: 2005 EN 61000-6-2: 2001
EN 61326:1997 +A1:1998 + A2:2001 +A3:2003 IEC 61326:1997 + A1:1998 + A2:2000 EN 61326-1 Ed. 1.0 EN 61326-1 :2013 IEC 61326-1 Ed. 2.0 (2012-07) IEC 61326:2006	EN 60601-1-2:2001 + A1:2006 IEC 60601-1-2:2001 EN 60601-1-2:2007 IEC 60601-1-2:2007 (Ed. 3.0)	EN 55103-1:1996 EN 55103-2 :1996 EN 55103-1:2005 EN 55103-2:2005
EN 300 386 V.1.3.1 EN 300 386 V.1.3.3 EN 300 386 V.1.4.1	EN 61000-3-3: 1995, +A1:2001 +A2:2005 IEC 61000-3-3: 1994, +A1:2001 +A2:2005 EN 61000-3-3:2008	EN 61000-3-2: 2000 +A2 :2005 IEC 61000-3-2: 2000 (Modified) +A1:2001 +A2:2004 EN 61000-3-2:2006
EN 50130-4: 1995 +A1:1998 + A2:2002 EN 50130-4:2011	ETSI EN 301 489-x ETSI EN 300 220-x	ETSI EN 300 339 Ed. 1

T.B.Ketterling

T.B. Ketterling, Nemko ELA Co-ordinator

EMC INTEGRITY, INC.
Test Report # TRB41001, Rev. A

Basic Standards		
EN 61000-4-2:1995, +A1:1998, +A2:2000 IEC 61000-4-2:1995, +A1:1998, +A2:2000 EN 61000-4-2 : 2009 EN 61000-4-2 :2008 (ed. 2) IEC 61000-4-2:2001 (ed. 1.2)	EN 61000-4-3:2002, +A1:2002 IEC 61000-4-3:2002, +A1:2002 EN 61000-4-3 :2006 +A1 :2006 +A2 :2006 IEC 61000-4-3 (Ed. 3.0) +A1 :2007 +A2 :2010	EN 61000-4-4:1995, +A1:2002, +A2:2002 IEC 61000-4-4:1995, +A1:2000, +A2:2001 EN 61000-4-4:2004 IEC 61000-4-4 Ed. 2.0 IEC 61000-4-4:2012
EN 61000-4-5:1995, +A1:2001 IEC 61000-4-5:1995, +A1:2000 EN 61000-4-5 :2006 IEC 61000-4-5 Ed. 2.0	EN 61000-4-6:1996, +A1:2001 IEC 61000-4-6:1996, +A1:2000 EN 61000-4-6 : 2009 IEC 61000-4-6 Ed. 2.2 IEC 61000-4-6 :2008	EN 61000-4-8:1994, +A1:2001 IEC 61000-4-8:1994, +A1:2001 IEC 61000-4-8 Ed. 1.1 IEC 61000-4-8 :2001 IEC 61000-4-8 :2009 EN 61000-4-8 :2010
EN 61000-4-11:2004 IEC 61000-4-11 Ed. 2.0 EN 61000-4-11:1994, +A1:2000 IEC 61000-4-11:1994, +A1:2000	BLANK	BLANK

T.B.Ketterling

T.B. Ketterling, Nemko ELA Co-ordinator

3(3)

NLA 3 ED3

United States Department of Commerce
National Institute of Standards and Technology



Certificate of Accreditation to ISO/IEC 17025:2005

NVLAP LAB CODE: 200737-0

EMC Integrity, Inc.
Longmont, CO

*is accredited by the National Voluntary Laboratory Accreditation Program for specific services,
listed on the Scope of Accreditation, for:*

ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

*This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality
management system (refer to joint ISO-ILAC-IAF Communiqué dated January 2009).*

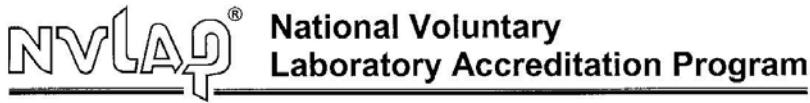
2014-07-01 through 2015-06-30

Effective dates



For the National Institute of Standards and Technology

NVLAP-01C (REV. 2009-01-28)



SCOPE OF ACCREDITATION TO ISO/IEC 17025:2005

EMC Integrity, Inc.
1736 Vista View Drive
Longmont, CO 80504
Mr. Vincent W. Greb
Phone: 303-776-7249 Fax: 303-776-7314
E-Mail: vinceg@emcintegrity.com
URL: <http://www.emcintegrity.com>

**ELECTROMAGNETIC COMPATIBILITY
AND TELECOMMUNICATIONS**

NVLAP LAB CODE 200737-0
Scope Revised: 2014-10-06

NVLAP Code Designation / Description

Emissions Test Methods

- | | |
|------------|--|
| 12/100063c | IEC 61000-6-3 (1996), EN 61000-6-3 (2001), A1 (2004): Electromagnetic Compatibility (EMC) - Part 6: Generic standards - Section 3: Emission standard for residential, commercial, and light-industrial environments. |
| 12/610006m | EN 61000-6-4 (2007): Electromagnetic Compatibility (EMC) - Part 6-4: Generic Standards - Emission Standard for Industrial Environments |
| 12/61326da | IEC 61326-1 Ed. 2.0 (2012): Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 1: General requirements |
| 12/CIS11f | AS/NZS CISPR 11 (2002): Industrial, scientific and medical (ISM) radio frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement |
| 12/CIS11g | IEC/CISPR 11, Ed. 4.1 (2004-06): Industrial, scientific and medical (ISM) radio-frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurements |
| 12/CIS11h | AS/NZS CISPR 11 (2004): Industrial, scientific and medical (ISM) radio frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement |
| 12/CIS11i | IEC/CISPR 11, Ed. 4.1 (2004-06) + A1(2004): Industrial, scientific and medical (ISM) radio frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement |

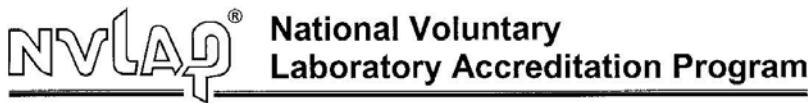
2014-07-01 through 2015-06-30

Effective dates

For the National Institute of Standards and Technology

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NVLAP-01S (REV. 2005-05-19)



ELECTROMAGNETIC COMPATIBILITY
AND TELECOMMUNICATIONS

NVLAP LAB CODE 200737-0
Scope Revised: 2014-10-06

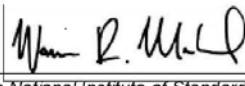
NVLAP Code Designation / Description

- | | |
|------------|---|
| 12/CIS11j | EN 55011 (1998) + A1(1999), A2(2002): Industrial, scientific and medical (ISM) radio frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement |
| 12/CIS11k | IEC/CISPR 11 (2003), EN 55011 (1998), A2(2002): Limits and Methods of Measurement of Electromagnetic Disturbance Characteristics of Industrial, Scientific, and Medical Radio-Frequency Equipment |
| 12/CIS11m2 | EN 55011 (2009) + A1 (2010): Industrial, scientific and medical (ISM) radio-frequency equipment - Electromagnetic disturbance characteristics - Limits and methods of measurement |
| 12/CIS11p | IEC/CISPR 11 Ed. 5 (2009-05): Industrial, scientific and medical equipment - Radio-frequency disturbance characteristics - Limits and methods of measurement |
| 12/CIS14b1 | AS/NZS CISPR 14-1 (2003): Electromagnetic Compatibility - Requirements for household appliances, electric tools and similar apparatus - Part 1: Emission |
| 12/CIS14x | IEC/CISPR 14-1, Ed. 4 (2003): Electromagnetic Compatibility - Requirements for household appliances, electric tools and similar apparatus - Part 1: Emission |
| 12/CIS22 | IEC/CISPR 22 (1997) & EN 55022 (1998) + A1(2000): Limits and methods of measurement of radio disturbance characteristics of information technology equipment |
| 12/CIS22a | IEC/CISPR 22 (1993) and EN 55022 (1994): Limits and methods of measurement of radio disturbance characteristics of information technology equipment, Amendment 1 (1995) and Amendment 2 (1996) |
| 12/CIS22a4 | IEC/CISPR 22 (1993) & EN 55022 (1994)+A1(1995), A2(1997): Limits and methods of measurement of radio disturbance characteristics of information technology equipment |
| 12/CIS22b | CNS 13438 (1997): Limits and Methods of Measurement of Radio Interference Characteristics of Information Technology Equipment |
| 12/CIS22c | IEC/CISPR 22, Fourth Edition (2003-04) & EN 55022 (1998): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement |

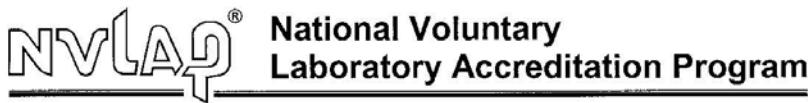
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- | | |
|------------|--|
| 12/CIS22c1 | IEC/CISPR 22, Edition 5 (2005) and EN 55022 (1998): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement |
| 12/CIS22c3 | IEC/CISPR 22, Edition 5 (2005) + A1(2005): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement |
| 12/CIS22c4 | EN 55022 (1998) + A1(2000) + A2(2003): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement |
| 12/CIS22f | CNS 13438 (2006) (up to 6GHz): Limits and Methods of Measurement of Radio Interference Characteristics of Information Technology Equipment |
| 12/CIS22i | IEC/CISPR 22, Edition 5.2 (2006-03): Limits and Methods of Measurement of Radio Disturbance Characteristics of Information Technology Equipment |
| 12/CIS22j | EN 55022 (2006): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement |
| 12/CIS22j1 | EN 55022 (2006) + A1 (2007): Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement |
| 12/CIS22j2 | EN 55022:2010: Information technology equipment. Radio disturbance characteristics. Limits and methods of measurement |
| 12/CIS22k | IEC/CISPR 22 (2008-09): Limits and Methods of Measurement of Radio Disturbance Characteristics of Information Technology Equipment |
| 12/CIS32a | CISPR 32, Ed. 1 (2012-01): Electromagnetic compatibility of multimedia equipment - Emission requirements |
| 12/CIS32ba | EN 55032:2012/AC:2013: Electromagnetic compatibility of multimedia equipment. Emission requirements |
| 12/EM02d | IEC 61000-3-2, Edition 2.2 (2004-11): Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for harmonic current emissions (equipment input current <= 16 A per phase) |

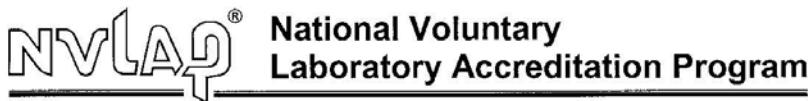
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- | | |
|------------|---|
| 12/EM02k | GB 17625.1 (2003): Electromagnetic compatibility (EMC) - Part 3: Limits - Section 2. Limits for harmonic current emissions (equipment input current <= 16A per phase) |
| 12/EM03b | IEC 61000-3-3, Edition 1.1(2002-03) & EN 61000-3-3, A1(2001): EMC - Part 3-3: Limits - Limitations of voltage changes, voltage fluctuations and flicker, in public low-voltage supply-systems, for equipment with rated current <=16 A per phase and not subject to conditional connections |
| 12/EM03g | IEC 61000-3-3, Edition 1.1 (2003) +A2 (2005): EMC Part 3-3: Limits - Limitations of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current <= 16 A per phase and not subject to conditional connections |
| 12/EM12c | IEC 61000-3-12 Ed. 2.0 (2011): Electromagnetic compatibility (EMC) - Part 3-12: Limits - Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current >16 A and = 75 A per phase |
| 12/EM12d | EN 61000-3-12 (2011): Electromagnetic Compatibility (EMC) - PART 3-12: Limits for harmonic currents produced by equipment connected to public low-voltage systems with input current greater than 16A and less than or equal to 75A |
| 12/F18 | FCC OST/MP-5 (1986): FCC Methods of Measurement of Radio Noise Emissions for ISM Equipment (cited in FCC Method 47 CFR Part 18 - Industrial, Scientific, and Medical Equipment) |
| 12/FCC15b | ANSI C63.4 (2003) with FCC Method 47 CFR Part 15, Subpart B: Unintentional Radiators |
| 12/FCC15bb | ANSI C63.4 (2009) with FCC Method 47 CFR Part 15, Subpart B: Unintentional Radiators |
| 12/KN11d1 | KN11 (Annex 3) with RRA Announce 2008-11 (Dec. 16, 2008): Conformity Assessment Procedure for Electromagnetic Interference; With KN 11 (Annex 3) |
| 12/KN16 | Korea RRA Notice No. 2008-11 (Dec. 16, 2008): Conformity Assessment Procedures for Electromagnetic Interference using KN 16-1-1, KN 16-1-2, KN 16-1-3, KN 16-1-4, KN 16-1-5, KN 16-2-1, KN 16-2-2, KN 16-2-3, KN 16-2-4 (2008-05) |

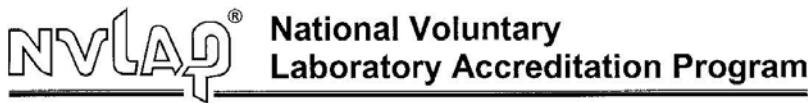
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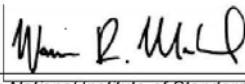
NVLAP Code Designation / Description

- 12/KN22 KN22 with RRL Notice No. 2005-82 (Sept. 29, 2005); RRL Notice No. 2005-82: Technical Requirements for Electromagnetic Interference Annex 8 (KN-22), RRL Notice No. 2005-131: Conformity Assessment Procedures for Electromagnetic Interference
- 12/KN22e KN22 (2008-5) with RRL Notice No. 2008-3 (May 20, 2008); Conformity Assessment Procedure for Electromagnetic Interference; With KN 22
- 12/KN22f KN22 (Annex 5) with RRA Announce 2010-5 (Dec 24, 2010); Conformity Assessment Procedure for Electromagnetic Interference; With KN 22 (Annex 5)
- 12/RRA04a RRA 2014-8 and RRA 2014-37 (June 23, 2014); Technical Requirements and Test Methods for Electromagnetic Interference; K only (See specific Annexes listed on scope)
- 12/RRA105 RRA Announce 2010-5, K only (December 24, 2010); Conformity Assessment Procedure for Electromagnetic Interference (K only)
- 12/RRA1118 RRA Public Notification 2011-18, K only (July 5, 2011); Technical Requirements for Electromagnetic Interference (K only)
- 12/T51 AS/NZS CISPR 22 (2002) and AS/NZS 3548 (1997); Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment
- 12/T51b1 AS/NZS CISPR 22 (2009); Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement
- 12/TCVNa TCVN 7189:2009 (CISPR 22:2006); Information Technology Equipment-Radio disturbance characteristics - Limits and methods of measurement
- 12/VCCIE Agreement of VCCI V-3 (2009.04); Agreement of Voluntary Control Council for Interference by Information Technology Equipment - Technical Requirements; V-3/2009.04 (radiated disturbance above 1 GHz)
- 12/VCCIG Agreement of VCCI V-3 (2011.04); Agreement of VCCI Council - Technical Requirements: V-3/2011.04 (including radiated disturbance above 1 GHz)

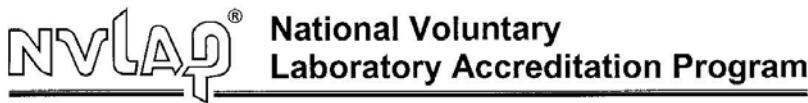
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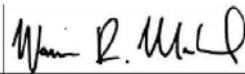
12/VCCIi Agreement of VCCI V-3 (2013.04): Agreement of VCCI Council - Technical Requirements: V-3/2013.04 (including radiated disturbance above 1 GHz)

Immunity Test Methods

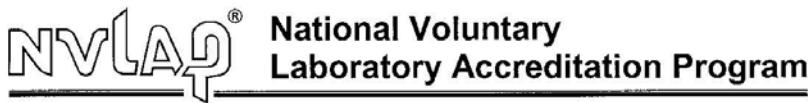
- 12/610006h IEC 61000-6-1, 2nd edition (2005-03): Electromagnetic compatibility (EMC) - Part 6: Generic standards - Section 1: Immunity for residential, commercial and light-industrial environments
- 12/610006i IEC 61000-6-2, Edition 2.0 (2005-01): Electromagnetic compatibility (EMC) - Part 6-2: Generic standards - Immunity for industrial environments
- 12/61326aa EN 61326-1:2013: Electrical equipment for measurement, control and laboratory use - EMC requirements - Part 1: General requirements
- 12/CIS24g CISPR 24 ed2.0 (2010-08): Information technology equipment - Immunity characteristics - Limits and methods of measurement
- 12/CIS24h EN 55024 (2010): Information technology equipment. Immunity characteristics. Limits and methods of measurement
- 12/I01b IEC 61000-4-2 (2001); EN 61000-4-2 (2001), A2 (2001): Electrostatic Discharge Immunity Test
- 12/I01c EN 61000-4-2 +A1(1998) +A2(2001): Electrostatic Discharge Immunity Test
- 12/I01d IEC 61000-4-2, Ed. 2.0 (2008-12): Electromagnetic compatibility (EMC) - Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test
- 12/I01f EN 61000-4-2 (2009-05): Electromagnetic compatibility (EMC) - Part 4-2 : Testing and measurement techniques - Electrostatic discharge immunity test
- 12/I02b IEC/EN 61000-4-3, Ed. 2.1 (2002), A1 (2002); EN 61000-4-3: Radiated, radio-frequency, electromagnetic field immunity test
- 12/I02c IEC 61000-4-3 (1995), A1(1998), A2(2000): Radiated, radio-frequency, electromagnetic field immunity test

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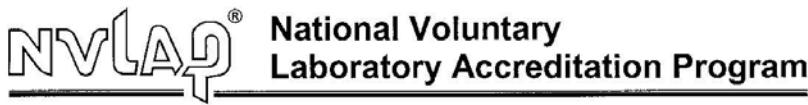
NVLAP Code Designation / Description

- | | |
|-----------|---|
| 12/I02f | EN 61000-4-3 (2002) + A1(2002): Radiated, radio-frequency, electromagnetic field immunity test |
| 12/I02ggg | IEC 61000-4-3, Ed. 3.0 (2006-02) + A1 (2007) + A2 (2010): Electromagnetic compatibility (EMC) - Part 4-3: Testing measurement techniques - Radiated, radio-frequency, electromagnetic field immunity test |
| 12/I02hhh | EN 61000-4-3 (2006) +A1 (2008) + A2 (2010): Electromagnetic compatibility (EMC). Testing and measurement techniques. Radiated, radio- Frequency, electromagnetic field immunity test |
| 12/I03c | IEC 61000-4-4, Ed. 2.0 (2004-07): Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test |
| 12/I03e | EN 61000-4-4 (2004): Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test |
| 12/I04aa | IEC 61000-4-5, Ed. 2.0 (2005-11); EN 61000-4-5: Electromagnetic Compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test |
| 12/I04b | IEC 61000-4-5 (2001), A1(2000); EN 61000-4-5(2001), A1(2000): Surge Immunity Test |
| 12/I04d | BS EN 61000-4-5 (2006): Electromagnetic compatibility (EMC). Testing and measurement techniques. Surge immunity test |
| 12/I05d | IEC 61000-4-6, Ed. 2.1 (2004); EN 61000-4-6: Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields |
| 12/I05e | EN 61000-4-6 (1996) + A1 (2001): Immunity to Conducted Disturbances, Induced by Radio Frequency Fields |
| 12/I05f1 | IEC 61000-4-6 Ed. 3.0 (2008): Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields |

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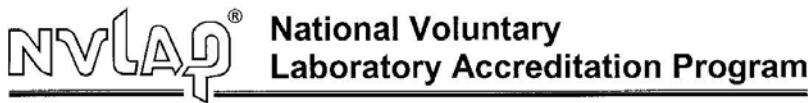
NVLAP Code Designation / Description

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|----------|--|
| 12/I05j | EN 61000-4-6 (2009): Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields |
| 12/I06b | IEC 61000-4-8 (2001), A1(2000); EN 61000-4-8 (2001),A1(2000): Power Frequency Magnetic Field Immunity Test |
| 12/I06c | EN 61000-4-8 (1993) + A1 (2001): Power Frequency Magnetic Field Immunity Test |
| 12/I06e | IEC 61000-4-8 (2009): Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test |
| 12/I06f | EN 61000-4-8:2010: Electromagnetic compatibility (EMC). Testing and measurement techniques. Power frequency magnetic field immunity test |
| 12/I07c | IEC 61000-4-11, Ed. 2 (2004-03) & EN 61000-4-11: Electromagnetic compatibility (EMC) - Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests |
| 12/I07e | EN 61000-4-11 (1994), A1 (2001): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests |
| 12/I07f | EN 61000-4-11 (2004): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests |
| 12/KN11a | KN 61000-4-11 with RRL Notice No. 2005-130 (Dec 27, 2005): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests |
| 12/KN11f | KN 61000-4-11 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests |
| 12/KN11h | KN 61000-4-11 (Annex 1-7) RRA Announce 2010-6 (Dec.24, 2010): Conformity Assessment Procedure for EMS (Voltage Dips, Short Interruptions and Voltage Variations Immunity tests) |

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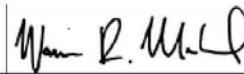
- 12/KN24 KN24 (December 2005) with RRL Notice No. 2005-83: Information Technology Equipment - immunity characteristics - limits and methods of measurements
- 12/KN24d KN 24 (2008-5) with RRL Notice No. 2008-4 (May 20, 2008): Information Technology Equipment - immunity characteristics - limits and methods of measurements
- 12/KN24e KN 24 (Annex 5) with RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Information technology equipment - Immunity characteristics - Limits and methods of measurement)
- 12/KN2a KN 61000-4-2 with RRL Notice No. 2005-130 (Dec. 27, 2005): Electrostatic Discharge Immunity Test
- 12/KN2c KN 61000-4-2 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Electrostatic Discharge Immunity Test
- 12/KN2e KN 61000-4-2 (Annex 1-1) RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Electrostatic Discharge Immunity Test)
- 12/KN3a KN 61000-4-3 with RRL Notice No. 2005-130 (Dec. 27, 2005): Radiated, radio-frequency, electromagnetic field immunity test
- 12/KN3c KN 61000-4-3 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Radiated, radio-frequency, electromagnetic field immunity test
- 12/KN3e KN 61000-4-3 (Annex 1-2) RRA Announce 2010-6 (Dec. 24, 2010): Radiated, radio-frequency, electromagnetic field immunity test
- 12/KN4a KN 61000-4-4 with RRL Notice No. 2005-130 (Dec. 27, 2005): Electromagnetic compatibility (EMC): Testing and measurement techniques - Electrical Fast Transient/Burst Immunity
- 12/KN4c KN 61000-4-4 (2008-5); RRL Notice No. 2008-5 (May 20, 2008): Electromagnetic compatibility (EMC): Testing and measurement techniques - Electrical Fast Transient/Burst Immunity Test

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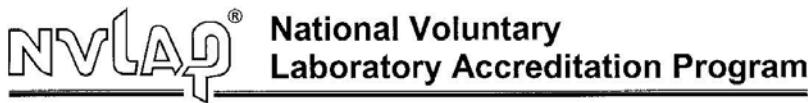
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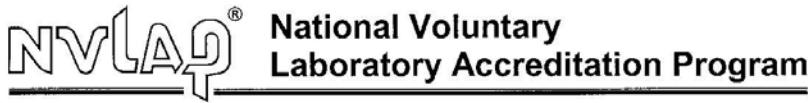
NVLAP Code Designation / Description

- | | |
|-----------|---|
| 12/KN4e | KN 61000-4-4 (Annex 1-3) RRA Announce 2010-6 (Dec. 24, 2010): Electromagnetic compatibility (EMC): Testing and measurement techniques - Electrical Fast Transient/Burst Immunity Test |
| 12/KN5a | KN 61000-4-5 with RRL Notice No. 2005-130 (Dec. 27, 2005): Surge Immunity Test |
| 12/KN5c | KN 61000-4-5 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Surge Immunity Test |
| 12/KN5e | KN 61000-4-5 (Annex 1-4) RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Surge Immunity Test) |
| 12/KN6a | KN 61000-4-6 with RRL Notice No. 2005-130 (Dec. 27, 2005): Electromagnetic compatibility (EMC): Testing and measurement techniques - Immunity to conducted disturbances, |
| 12/KN6c | KN 61000-4-6 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Electromagnetic compatibility (EMC): Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields |
| 12/KN6e | KN 61000-4-6 (Annex 1-5) RRA Announce 2010-6 (Dec. 24, 2010): Electromagnetic compatibility (EMC): Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields |
| 12/KN8a | KN 61000-4-8 with RRL Notice No. 2005-130 (Dec. 27, 2005): Power Frequency Magnetic Field Immunity Test |
| 12/KN8c | KN 61000-4-8 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Power Frequency Magnetic Field Immunity Test |
| 12/KN8e | KN 61000-4-8 (Annex 1-6) RRA Announce 2010-6 (Dec. 24, 2010): Conformity Assessment Procedure for EMS (Power Frequency Magnetic Field Immunity Test) |
| 12/RRA04b | RRA 2014-09 and RRA 2014-38 (June 23, 2014) K only: Technical Requirements and Test Methods for Electromagnetic Susceptibility; Korean only (See specific annexes listed on scope) |

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- 12/RRA106 RRA Public Notification 2010-6, December 24, 2010 (K only): Conformity Assessment Procedure for Electromagnetic Susceptibility (K only)
- 12/RRA1117 RRA Public Notification 2011-17, K only (July 5, 2011): Technical Requirements for Electromagnetic Susceptibility, K only

Product Safety Test Methods

- 12/60601ab IEC 60601-1-2, Ed. 3.0 (2007): Medical electrical equipment - Part 1-2: General requirements for safety - Collateral standard: Electromagnetic compatibility - Requirements and tests
- 12/60601ac KN 60601-1-2 (2008-5); RRL Notice No. 2008-4 (May 20, 2008): Medical electrical equipment - Part 1-2: general requirements for safety - collateral standard: electromagnetic compatibility - requirements and tests
- 12/60601h1 EN 60601-1-2 (2007): Medical electrical equipment - Part 1-2: General requirements for safety - Collateral standard: EMC - Requirements and tests

MIL-STD-462 : Conducted Emissions

- 12/A20 MIL-STD-461 Version F Method CE102
- 12/A21 MIL-STD-461 Version F Method CE106

MIL-STD-462 : Radiated Emissions

- 12/D11 MIL-STD-461 Version F Method RE102
- 12/D12 MIL-STD-461 Version F Method RE103

MIL-STD-462 : Radiated Susceptibility

- 12/E16 MIL-STD-461 Version F Method RS103

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